

# AUDIO DSP WITH ANALOG INTERFACE

Check for Samples: TAS3204

#### Introduction 1

- 1.1 Features
- Digital Audio Processor
  - Fully Programmable With the Graphical, Drag-and-Drop PurePath Studio™ Software Development Environment
  - 135-MHz Operation
  - 48-Bit Data Path With 76-Bit Accumulator
  - Hardware Single-Cycle Multiplier (28 × 48)
  - Five Simultaneous Operations Per Clock Cycle
  - Usable 768 Words Data RAM (48 Bit), Usable 1k Coefficient RAM (28 Bit)
  - Usable 2.5K Program RAM
  - 122 ms at 48 kHz, 5.8k Words 24-Bit Delay Memory
  - Slave Mode F<sub>s</sub> is 44.1 kHz and 48 kHz
- Master Mode F<sub>s</sub> is 48 kHz
- Analog Audio Input/Output
  - Two 3:1 Stereo Analog Input MUXes
  - Four Differential ADCs (102 dB DNR, Typical)
  - Four Differential DACs (105 dB DNR, Typical)
- Digital Audio Input/Output
  - Two Synchronous Serial Audio Inputs (Four Channels)
  - Two Synchronous Serial Audio Outputs (Four Channels)
  - Input and Output Data Formats: 16-, 20-, or 24-Bit Data Left, Right, and I<sup>2</sup>S
- System Control Processor
  - Embedded 8051 WARP Microprocessor
  - Programmable Using Standard 8051 C Compilers
  - Up to Four Programmable GPIO Pins
- General Features
  - Two I<sup>2</sup>C Ports for Slave or Master Download
  - Single 3.3-V Power Supply
  - Integrated Regulators

## 1.2 Applications

- MP3 Player/Music Phone Docks
- Speaker Bars
- Mini/Micro-Component Systems
- **Musical Instruments**
- Speaker Equalization
- **Studio Monitors**



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## 1.3 Description

The TAS3204 is a highly-integrated audio system-on-chip (SOC) consisting of a fully-programmable, 48-bit digital audio processor, a 3:1 stereo analog input MUX, four ADCs, four DACs, and other analog functionality. The TAS3204 is programmable with the graphical PurePath Studio<sup>™</sup> suite of DSP code development software. PurePath Studio is a highly intuitive, drag-and-drop environment that minimizes software development effort while allowing the end user to utilize the power and flexibility of the TAS3204's digital audio processing core.

TAS3204 processing capability includes speaker equalization and crossover, volume/bass/treble control, signal mixing/MUXing/splitting, delay compensation, dynamic range compression, and many other basic audio functions. Audio functions such as matrix decoding, stereo widening, surround sound virtualization and psychoacoustic bass boost are also available with either third-party or TI royalty-free algorithms.

The TAS3204 contains a custom-designed, fully-programmable 135-MHz, 48-bit digital audio processor. A 76-bit accumulator ensures that the high precision necessary for quality digital audio is maintained during arithmetic operations.

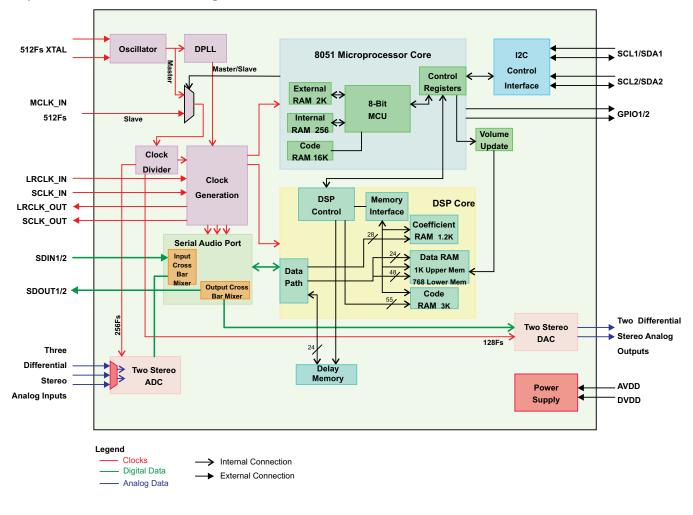
Four differential 102 dB DNR ADCs and four differential 105 dB DNR DACs ensure that high quality audio is maintained through the whole signal chain as well as increasing robustness against noise sources such as TDMA interference.

The TAS3204 is composed of eight functional blocks:

- 1. Clocking System
- 2. Digital Audio Interface
- 3. Analog Audio Interface
- 4. Power supply
- 5. Clocks, digital PLL
- 6. I<sup>2</sup>C control interface
- 7. 8051 MCUcontroller
- 8. Audio DSP digital audio processing



### **Expanded Functional Block Diagram**



## 1.4 Ordering Information

T <sub>A</sub>	PLASTIC 64-PIN PQFP (PN) <sup>(1)(2)</sup>	
0°C to 70°C	TAS3204PAG	

(1) Package drawings, thermal data, and symbolization are available at www.ti.com/packaging.

(2) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI website at <a href="http://www.ti.com">www.ti.com</a>.

## TAS3204

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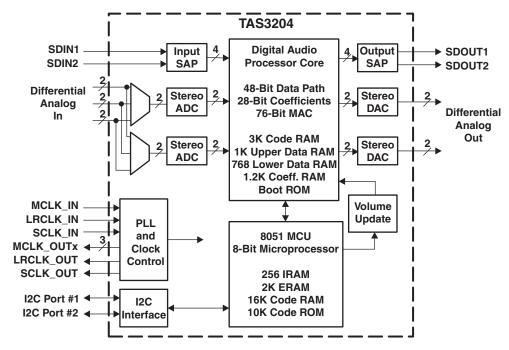
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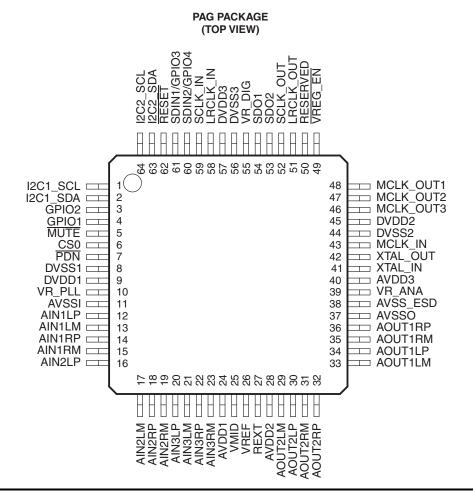
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## 2 Physical Characteristics



## 2.1 Terminal Assignments



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#### 22 **Terminal Descriptions**

.2 Terminal Descriptions						
	AL NO.	INPUT/ OUTPUT <sup>(1)</sup>	PULLUP/ PULLDOWN <sup>(2)</sup>	DESCRIPTION		
AIN1LM	13		Pull to VMID <sup>(3)</sup>	Analog channel 1 left negative input		
AIN1LM AIN1LP	13	Analog Input Analog Input		Analog channel 1 left positive input		
AIN1RM	12	Analog Input	Pull to VMID <sup>(3)</sup>	Analog channel 1 right negative input		
AINTRM AINTRP	13	Analog Input Analog Input		Analog channel 1 right positive input		
AIN1KI AIN2LM	14	Analog Input	Pull to VMID <sup>(3)</sup>	Analog channel 2 left negative input		
AIN2LM AIN2LP	16	Analog Input Analog Input		Analog channel 2 left positive input		
AIN2LF AIN2RM	10	Analog Input	Pull to VMID <sup>(3)</sup>	Analog channel 2 right negative input		
AIN2RM AIN2RP	19	0 1				
AIN3LM	21	Analog Input	Pull to VMID <sup>(3)</sup>	Analog channel 2 right positive input		
		Analog Input		Analog channel 3 left negative input		
AIN3LP	20	Analog Input	Pull to VMID <sup>(3)</sup>	Analog channel 3 left positive input		
AIN3RM	23	Analog Input		Analog channel 3 right negative input		
AIN3RP	22	Analog Input		Analog channel 3 right positive input		
AOUT1LM	33	Analog Output		Analog channel 1 left negative output		
AOUT1LP	34	Analog Output		Analog channel 1 left positive output		
AOUT1RM	35	Analog Output		Analog channel 1 right negative output		
AOUT1RP	36	Analog Output		Analog channel 1 right positive output		
AOUT2LM	29	Analog Output		Analog channel 2 left negative output		
AOUT2LP	30	Analog Output		Analog channel 2 left positive output		
AOUT2RM	31	Analog Output		Analog channel 2 right negative output		
AOUT2RP	32	Analog Output		Analog channel 2 right positive output		
AVDBit 1	24	Power		3.3-V analog power. This pin must be decoupled according to good design practices.		
AVSS1	11	Power		Analog ground		
AVDBit 2	28	Power		3.3-V analog power. This pin must be decoupled according to good design practices.		
AVSS2	37	Power		Analog ground		
AVDBit 3	40	Power		3.3-V analog power supply. This pin must be decoupled according to good design practices.		
AVSS3	38	Power		Analog ground		
CS0	6	Digital Input		I <sup>2</sup> C chip select		
DVDBit 1	9	Power		3.3-V digital power. This pin must be decoupled according to good design practices.		
DVSS1	8	Power		Digital ground		
DVDBit 2	45	Power		3.3-V digital power. This pin must be decoupled according to good design practices.		
DVSS2	44	Power		Digital ground		
DVDBit 3	57	Power		3.3-V digital power. This pin must be decoupled according to good design practices.		
DVSS3	56	Power		Digital ground		
GPIO1	4	Digital IO		General purpose input/output pin #1.		
GPIO2	3	Digital IO		General purpose input/output pin #2		
I2C1_SCL	1	Digital Input		Slave I <sup>2</sup> C serial control data interface input/output.		
I2C1_SDA	2	Digital I/O		Slave I <sup>2</sup> C serial clock input.		
I2C2_SCL	64	Digital Input		Master I <sup>2</sup> C serial control data interface input/output.		

 I = input; O = output
 All pullups are 20-μA *weak* pullups, and all pulldowns are 20-μA *weak* pulldowns. The pullups and pulldowns are included to ensure proper input logic levels if the terminals are left unconnected (pullups  $\rightarrow$  logic 1 input; pulldowns  $\rightarrow$  logic 0 input). Devices that drive inputs with pullups must be able to sink 20  $\mu$ A while maintaining a logic-0 drive level. Devices that drive inputs with pulldowns must be able to source 20  $\mu$ A while maintaining a logic-1 drive level.

Pull to VMID when analog input is in single-ended mode. (3)

6 Physical Characteristics



TERMINAL		INPUT/ PULLUP/				
NAME	NO.	OUTPUT <sup>(1)</sup> PULLDOWN <sup>(2)</sup>		DESCRIPTION		
I2C2_SDA	63	Digital I/O		Master I <sup>2</sup> C serial clock input.		
LRCLK_IN	58	Digital Input	Pulldown	Left/right (frame) clock input for I <sup>2</sup> S interface		
LRCLK_OUT	51	Digital Output		Left/right (frame) clock output for I <sup>2</sup> S interface		
MCLK_IN	43	Digital Input	Pulldown	Master clock input for I <sup>2</sup> S interface. Frequency = 512 x $F_s$		
MCLK_OUT1	48	Digital Output		Master clock output for I <sup>2</sup> S interface Frequency = 256 x $F_s$		
MCLK_OUT2	47	Digital Output		Programmable master clock output divider		
MCLK_OUT3	46	Digital Output		Programmable master clock output divider		
MUTE	5	Digital Input	Pulldown	This pin needs to be programmed as mute pin in the application code. In has no function in default after reset.		
PDN	7	Digital Input		Powerdown active LOW. After successful boot, its function is defined by the boot code.		
RESERVED	50	N/A	Pulldown	Pin must be connected to ground		
RESET	62	Digital Input	Pullup	Device reset. This pin is active low.		
REXT	27	Analog Output		This pin must be connected to a 22 k $\Omega$ (1% tolerance) external resistor to ground to set analog currents. Trace capacitance must be kept low.		
SCLK_IN	59	Digital Input		Serial (bit) clock input for I <sup>2</sup> S interface		
SCLK_OUT	52	Digital Output		Serial (bit) clock output for I <sup>2</sup> S interface		
SDIN1/GPIO3	61	Digital I/O	Pullup	Serial data input #1 for I <sup>2</sup> S interface / general purpose input/output #3		
SDIN2/GPIO4	60	Digital I/O	Pullup	Serial data input #2 for I <sup>2</sup> S interface / general purpose input/output #4		
SDOUT1	54	Digital Output		Serial data output #1 for I <sup>2</sup> S interface		
SDOUT2	53	Digital Output		Serial data output #2 for I <sup>2</sup> S interface		
VMID	25	Analog Output		Analog mid supply reference. This pin must be decoupled with a $0.1\text{-}\mu\text{F}$ low-ESR capacitor and an external $10\text{-}\mu\text{F}$ filter cap. $^{(4)}$		
VR_ANA	39	Power		Voltage reference for analog supply. A pin-out of the internally regulated 1.8 V power. A 0.1- $\mu$ F low ESR capacitor and a 4.7- $\mu$ F filter capacitor must be connected between this terminal and AVSS. This terminal must not be used to power external devices. <sup>(4)</sup>		
VR_DIG	55	Power		Voltage reference for digital supply. A pin-out of the internally regulated 1.8 V power. A 0.1- $\mu$ F low ESR capacitor and a 4.7- $\mu$ F filter capacitor must be connected between this terminal and DVSS. This terminal must not be used to power external devices. <sup>(4)</sup>		
VR_PLL	10	Power		Voltage reference for DPLL supply. A pin-out of internally regulated 1.8-V power supply. A 0.1- $\mu$ F low-ESR capacitor and a 4.7- $\mu$ F filter capacitor must be connected between this terminal and DVSS. This terminal must not be used to power external devices. <sup>(4)</sup>		
VREF	26	Analog Output		Band gap output. A 0.1- $\mu F$ low ESR capacitor should be connected between this terminal and AVSS. This terminal must not be used to power external devices. $^{(4)}$		
VREG_EN	49	Digital Input		Voltage regulator enable active low.		
XTAL_IN	41	Digital Input		Crystal input. Frequency = 512 x Fs		
XTAL_OUT	42	Digital Output		Crystal output. Frequency = 512 x Fs		

(4) If desired, low ESR capacitance values can be implemented by paralleling two or more ceramic capacitors of equal value. Paralleling capacitors of equal value provide an extended high frequency supply decoupling.

## 3 TAS3204 Clocking System

Clock management for the TAS3204 consists of two control structures:

- Core Clock management
  - Oversees the selection of the clock frequencies for the 8051 MCU, the I<sup>2</sup>C controller, and the audio DSP core
  - The master clock (MCLK\_IN or XTAL\_IN) is the source for these clocks.
  - In most applications, the master clock drives an on-chip digital phase-locked loop (DPLL), and the DPLL output drives the MCU and audio DSP clocks.
  - DPLL bypass mode is also available, in which the high-speed master clock directly drives the MCU and audio DSP clocks.
- Serial Audio Port (SAP) clock management
  - Oversees SAP master/slave mode
  - Controls output of SCLKOUT, and LRCLK in the SAP master mode

Figure 3-1 shows a block diagram of the TAS3204 clocking scheme.

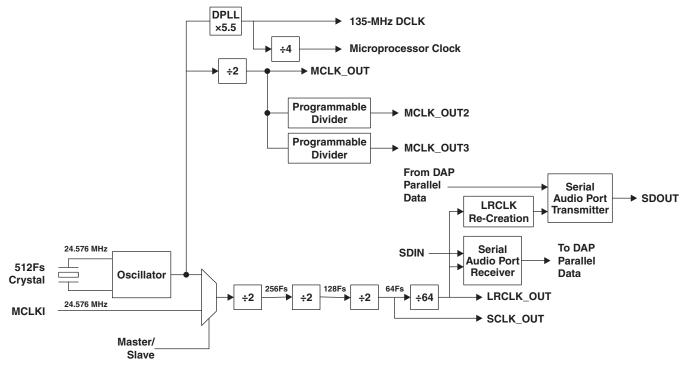


Figure 3-1. Clock Generation

## 3.1 Core Clock Management

The TAS3204 DSP, MCU, and I2C Controller core clocks are derived from the on chip oscillator provided that an external crystal and associated circutry are provided.

- DSP clock operates at a fixed frequency of 2816 x Fs
- MCU clock operates at a fixed frequency of 704 x Fs.
- I<sup>2</sup>controller core operates at a fixed frequency of (256 x Fs).



## 3.2 SAP Clock Management

The Serial Audio Port in the TAS3204 can be clocked in two modes of operation: Master and Slave. By default, the TAS3204 is configured in master mode.

**Clock Master operation:** In Clock Master operation, the onboard oscillator provides the reference for the SAP clock outputs provided an external crystal is present.

- LRCLK\_OUT fixed at a frequency of 48 kHz (Fs).
- SCLK\_OUT is fixed at a frequency of (64 x Fs).
- MCLK\_OUT is fixed at a frequency of (256 x Fs).
- In master mode, the external ASRC converts incoming serial audio data to 48-kHz sample rate synchronous to the internally generated serial audio data clocks.

**Clock Slave operation:** In Clock Slave operation, the SAP clock inputs are provided externally (that is, by a system controller) and passed through to the SAP Outputs. The MCLK\_IN signal is internally divided down and sent directly to the ADC and DAC blocks, therefore analog audio performace is dependant on the quality of the MCLK\_IN signal. As a result, degradation in analog performance is to be expected if the quality of MCLK\_IN (that is, jitter, phase noise, etc) is not robust.

DISCLAIMER: Analog performance is not ensured in slave mode, as the analog performance depends upon the quality of the MCLK\_IN. The TAS3204 is not robust with respect to MCLK\_IN errors (glitches, etc.); if the MCLK\_IN frequency changes under operation, the device must be reset.

- MCLK\_IN (512 × Fs),
- SCLK\_IN (64 × Fs), and
- LRCLK\_IN (Fs) are supplied externally by an clocking device.
- •

When the TAS3204 is used in a system in which the master clock frequency ( $f_{MCLK}$ ) can change, the TAS3204 must be reset during the frequency change. In these cases, the procedure shown in Figure 3-2 should be used.

In slave mode, all incoming serial audio data must be synchronous to an incoming LRCLK\_IN of 44.1 kHz or 48 kHz.

The TAS3204 only supports dynamic sample-rate changes between any of the supported sample frequencies when a fixed-frequency master clock is provided. During dynamic sample-rate changes, the TAS3204 remains in normal operation and the register contents are preserved. To avoid producing audio artifacts during the sample-rate changes, a volume or mute control can be included in the application firmware that mutes the output signal during the sample-rate change. The fixed-frequency clock can be provided by a crystal attached to XTAL\_IN and XTAL\_OUT or an external 3.3-V fixed-frequency TTL source attached to MCLK\_IN.

Changing the sample rate on the fly in slave mode should be handled by a host system controller. The TAS3204 does not include any internal clock error or click/pop detection managment. Customer specific DAP filter coefficients must be uploaded by a host system controller when changing the sample rate.



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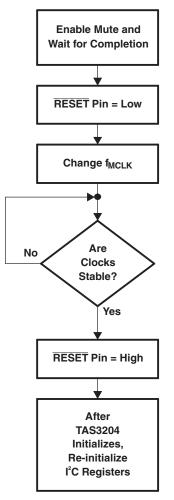


Figure 3-2. Master Clock Frequency (f<sub>MCLK</sub>) Change Procedure

F <sub>S</sub> Sample Rate (kHz)	Ch Per SDIN	MCLK/ LRCLK Ratio (× f <sub>S</sub> )	MCLK Freq (MHz)	SCLKIN Rate (× f <sub>S</sub> )	SCLK_IN Freq (MHz)	SCLK_OUT Rate (× f <sub>S</sub> )	Ch Per SDOUT	LRCLK (F <sub>S</sub> )	PLL Multiplier	F <sub>DSPCLK</sub> (MHz)	f <sub>dspclk</sub> /f <sub>s</sub>
	Slave Mode, 2 Channels In, 2 Channels Out										
44.1	2	512	22.579	64	2.822	64	2	64	5.5	124.2	2816
48	2	256	24.576	64	3.072	64	2	64	5.5	135.2	2816
	Master Mode, 2 Channels In, 2 Channels Out										
48	2	256	24.576	N/A	N/A	64	2	64	5.5	135.2	2816



## 4 Digital Audio Interface

## 4.1 Serial Audio Port (SAP)

The TAS3204 can accept four channels of 16, 20, or 24 bit digial serial audio in the I<sup>2</sup>S, discrete left justified, or discrete right justified formats.

The TAS3204 can provide four channels of 16, 20, or 24 bit digital serial audio in I<sup>2</sup>S, discrete left justified, or discrete right justified format. Output data rate is the same data rate as the input. The SDOUT output uses the SCLK\_OUT and LRCLK\_OUT signals to provide synchronization.

The TAS3204 supported data formats are listed in Table 4-1.

Input SAP (SDIN1, SDIN2)	Output SAP (SDOUT1, SDOUT2)
2-channel I <sup>2</sup> S	2-channel I <sup>2</sup> S
2-channel left-justified	2-channel left-justified
2-channel right-justified	2-channel right-justified

## Table 4-1. Supported Data Formats

Mode	Input Control IM[3:0]	Output Control OM[3:0]	Serial Format	Word Lengths	Data Rates (kHz)	MAX SCLK (MHz)
	0000	0000	Left-justified	16, 20, 24		
2-channel	0001	0001	Right-justified	16, 20, 24	32–48	3.072
	0010	0010	l <sup>2</sup> S	16, 20, 24		

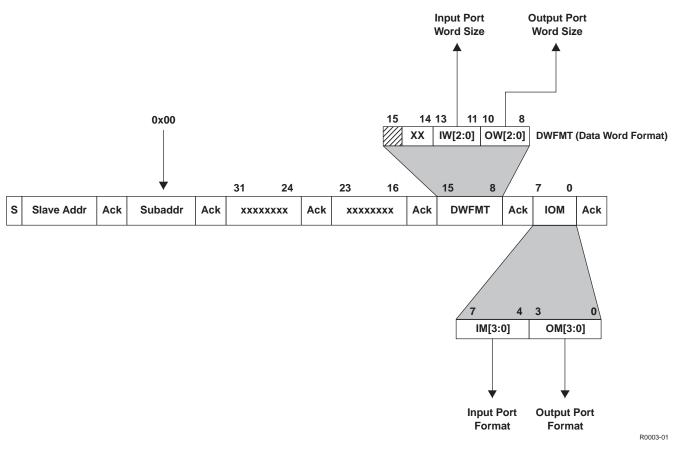
### Table 4-2. Serial Data Input and Output Formats

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## Figure 4-1. Serial Data Controls

IW1, OW1	IW0, OW0	FORMAT
0	0	Reserved
0	1	16-bit data
1	0	20-bit data
1	1	24-bit data

Following a reset, ensure that the clock register (0x00) is written before performing volume, treble, or bass updates.

Commands to reconfigure the SAP can be accompanied by mute and unmute commands for quiet operation. However, care must be taken to ensure that the mute command has completed before the SAP is commanded to reconfigure. Similarly, the TAS3204 should not be commanded to unmute until after the SAP has completed a reconfiguration. The reason for this is that an SAP configuration change while a volume or bass or treble update is taking place can cause the update not to be completed properly.

When the TAS3204 is transmitting serial data, it uses the negative edge of SCLK to output a new data bit. The TAS3204 samples incoming serial data on the rising edge of SCLK.



## 4.1.1 2-Channel I<sup>2</sup>S Timing

In 2-channel I<sup>2</sup>S timing, LRCLK is LOW when left-channel data is transmitted and HIGH when right-channel data is transmitted. SCLK is a bit clock running at 64 ×  $f_S$  which clocks in each bit of the data. There is a delay of one bit clock from the time the LRCLK signal changes state to the first bit of data on the data lines. The data is written MSB first and is valid on the rising edge of the bit clock. The TAS3204 masks unused trailing data-bit positions.

2-Channel I<sup>2</sup>S (Philips Format) Stereo Input/Output

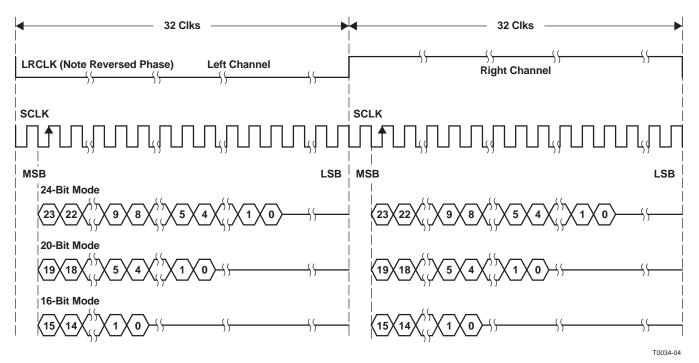


Figure 4-2. I<sup>2</sup>S 64f<sub>S</sub> Format



## 4.1.2 2-Channel Left-Justified Timing

In 2-channel left-justified timing, LRCLK is HIGH when left-channel data is transmitted and LOW when right-channel data is transmitted. SCLK is a bit clock running at 64 ×  $f_S$ , which clocks in each bit of the data. The first bit of data appears on the data lines at the same time LRCLK toggles. The data is written MSB first and is valid on the rising edge of the bit clock. The TAS3204 masks unused trailing data-bit positions.

2-Channel Left-Justified Stereo Input

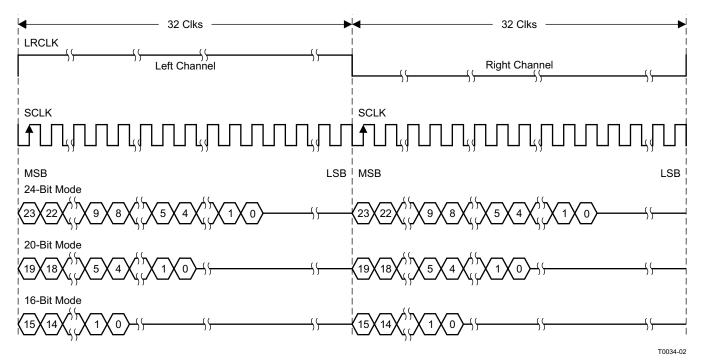


Figure 4-3. Left-Justified 64f<sub>S</sub> Format



## 4.1.3 2-Channel Right-Justified Timing

In 2-channel right-justified (RJ) timing, LRCLK is HIGH when left-channel data is transmitted and LOW when right-channel data is transmitted. SCLK is a bit clock running at  $64 \times f_S$  which clocks in each bit of the data. The first bit of data appears on the data lines 8 bit-clock periods (for 24-bit data) after LRCLK toggles. In the RJ mode, the last bit clock before LRCLK transitions always clocks the LSB of data. The data is written MSB first and is valid on the rising edge of the bit clock. The TAS3204 masks unused leading data-bit positions.

2-Channel Right-Justified (Sony Format) Stereo Input

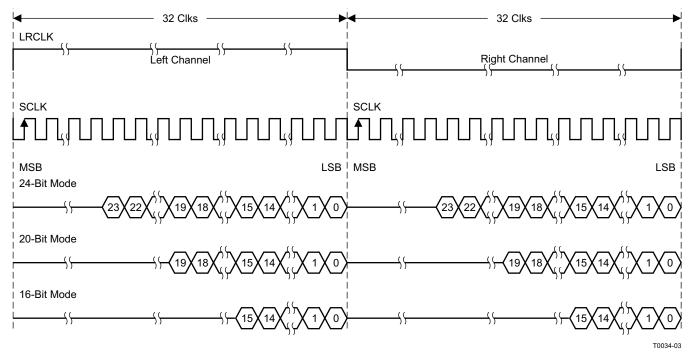


Figure 4-4. Right-Justified 64f<sub>s</sub> Format

## 4.1.4 SAP Input to SAP Output—Processing Flow

All SAP data format options other than  $I^2S$  result in a two-sample delay from input to output. If  $I^2S$  formatting is used for both the input SAP and the output SAP, the polarity of LRCLK must be inverted. However, if  $I^2S$  format conversions are performed between input and output, the delay becomes either 1.5 samples or 2.5 samples, depending on the processing clock frequency selected for the audio DSP core relative to the sample rate of the incoming data.

The I<sup>2</sup>S format uses the falling edge of LRCLK to begin a sample period, whereas all other formats use the rising edge of LRCLK to begin a sample period. This means that the input SAP and audio DSP core operate on sample windows that are 180° out of phase with respect to the sample window used by the output SAP. This phase difference results in the output SAP outputting a new data sample at the midpoint of the sample period used by the audio DSP core to process the data. If the processing cycle completes all processing tasks before the midpoint of the processing sample period, the output SAP outputs this processed data. However, if the processing time extends past the midpoint of the processing sample period. In the former case, the delay from input to output is 1.5 samples. In the latter case, the delay from input to output is 2.5 samples.

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The delay from input to output can thus be either 1.5 or 2.5 sample times when data format conversions are performed that involve the  $I^2S$  format. However, which delay time is obtained for a particular application is determinable and fixed for that application, providing care is taken in the selection of MCLK\_IN/XTAL\_IN with respect to the incoming sample clock, LRCLK.



## 5 Analog Audio Interface

## 5.1 Analog to Digital Converters ADCs

The TAS3204 has three differential analog stereo inputs that can be sent to either of two ADCs to be converted to digital data. The input multiplexers include a preamplifier. This amplifier is driving the ADCs, and it is digitally controlled with changes synchronized with the sample clock of the ADC. Minimal crosstalk between selected channels and unselected channels is maintained. When inputs are not needed they are configured for minimal noise. Also included in this module are two fully differential over sampled stereo ADCs. The ADCs are sigma-delta modulators with 256 times over-sampling ratio. Because of the over-sampling nature of the audio ADCs and integrated digital decimation filters, requirements for analog anti-aliasing filtering are relaxed. Filter performance for the ADCs are specified under physical characteristics.

## 5.2 Digital to Analog Converters DACs

The TAS3204 has two stereo audio DACs, each of which consists of a digital interpolation filter, digital sigma-delta modulator and an analog reconstruction filter. Each DAC can operate a maximum sampling frequency of 48 kHz. Each DAC upsamples the incoming data by 128 and performs interpolation filtering and processing on this data before conversion to a stereo analog output signal. The sigma-delta modulator always operates at a rate of 128x xFs, which ensures that quantization noise generated within the modulator stays low within the frequency band below Fs/2.4 at all sample rates. The digital interpolation filters for interpolation from Fs to 8xFs are included in the audio DSP upper memory (reserved for analog processing), while interpolation from 8xFs to 128 x Fs is done in a dedicated hardware sample and hold filter. The TAS3204 includes two stereo line driver outputs. All line drivers are capable of driving up to a 10-k $\Omega$  load. Each stereo output can be in power-down mode when not used. Popless operation is achieved by conforming to start and stop sequences in the device controller code.

## 5.3 Analog Reference System

This module provides all internal references needed by the analog modules. It also provides bias currents for all analog blocks. External decoupling capacitors are needed along with an external 1% tolerance resistor to set the internal bias currents. It includes a band-gap reference and several voltage buffers and a tracking current reference. The TAS3204 also uses an internally generated mid supply that is used to rereference all analog inputs and is present on all analog outputs. VMID is the analog mid supply and can be used when buffered externally to rereference the analog inputs and outputs. The voltage reference REXT requires a  $22 \cdot k\Omega$  1% resistor to ground. The reference system can be powered down separately.



## 6 Embedded MCUcontroller

The 8051 MCUcontroller receives and distributes I<sup>2</sup>C data, and participates in most processing tasks requiring multiframe processing cycles. The MCU has its own data RAM for storing intermediate values and queuing I<sup>2</sup>C commands, a fixed boot-program ROM, and a program RAM. The MCU boot program cannot be altered. The MCU controller has specialized hardware for master and slave interface operation, volume updates, and a programmable interval timer interrupt. For more information see the *TAS3108/TAS3108IA Firmware Programmer's Guide* (SLEU067).

Once the MCUcontroller program memory has been loaded, it cannot be updated until the TAS3204 has been reset.

## 6.1 MCU Addressing Modes

The 256 bytes of internal data memory address space is accessible using indirect addressing instructions (including stack operations). However, only the lower 128 bytes are accessible using direct addressing. The upper 128 bytes of direct address Data Memory space are used to access Extended Special Function Registers (ESFRs).

## 6.1.1 Register Banks

There are four directly addressable register banks, only one of which may be selected at one time. The register banks occupy Internal Data Memory addresses from 00 hex to 1F hex.

## 6.1.2 Bit Addressing

The 16 bytes of Internal Data Memory that occupy addresses from 20 hex to 2F hex are bit addressable. SFRs that have addresses of the form 1XXXX000 binary are also bit addressable.

## 6.1.3 External Data Memory

External data memory occupies a  $2K \times 8$  address space. This space contains the External Special Function Data Registers (ESFRs). The ESFR permit access and control of the hardware features and internal interfaces of the TAS3204.

## 6.1.4 Extended Special Function Registers

ESFRs provide signals needed for the M8051 to control the different blocks in the device. ESFR is an extension to the M8051. Figure 6-1 shows how these registers are arranged.

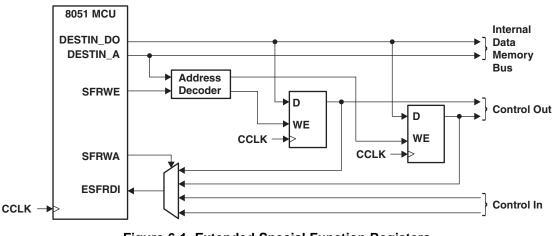


Figure 6-1. Extended Special Function Registers



## 6.1.5 Memory Mapped Registers for DAP Data Memory

The following memory mapped registers are used for communication with the digital audio processor.

	-	
Address	Register	Comment
0x0300	Dither Seed	Sets the dither seed value
0x0301	PC Start	Sets the starting address of the DAP
0x0302	Reserved	Reserved

### **Table 6-1. Memory Mapped Registers**

Note that TAS3204 has the same memory mapped registers distinction of upper and lower memory for these registers.

## 6.2 Boot Up Sequence

On power up of the TAS3204 or immediatly following a reset, the slave interface is disabled and the master interface is enabled. Using the master interface, the TAS3204 automatically tests to see if an I<sup>2</sup>C EEPROM is at address 1010x. The value x can be chip select, other information, or don't cares, depending on the EEPROM selected. If an EEPROM is present and it contains the correct header information and one or more blocks of program/memory data, the TAS3204 loads the program, coefficient, and/or data memories from the EEPROM. If a EEPROM is present, the download is complete when a header is read that has a zero-length data segment. At this point, the TAS3204 disables the master I<sup>2</sup>C interface, enables the slave I<sup>2</sup>C interface, and starts normal operation.

If no EEPROM is present or if an error occurred during the EEPROM read, TAS3204 disables the master I<sup>2</sup>C interface, enables the slave I<sup>2</sup>C interface, and loads the default configuration stored in the ROM. In this default configuration, the TAS3204 streams audio from input to output if the GPIO pin is LOW.

The master and slave interfaces do not operate simultaneously.

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## 7 Digital Audio Processor

The DAP arithmetic unit is a fixed-point computational engine consisting of an arithmetic unit and data and coefficient memory blocks. The primary features of the DAP are:

- Two pipe parallel processing architecture
  - 48-bit data path with 76-bit accumulator
  - Hardware single cycle multiplier (28×48)
  - Three 48-bit general-purpose data registers and one 28-bit coefficient register
  - Four simultaneous operations per machine cycle
  - Shift right, shift left and bi-modal clip
  - Log2/Alog2
  - Magnitude Truncation
- Hardware acceleration units
  - Soft volume controller
  - Delay memory
  - Dither generator
  - log2/2× estimator
- 1024 + 768 dual port ports words of data (24 and 48 bits, respectively)
- 1228 words of coefficient memory (28 bits)
- 3K word of program RAM (55 bits)
- 5.88K words of 24-bits delay memory (1.22 ms)
- Coefficient RAM, data RAM, LFSR seed, program counter, and memory pointers are all mapped into the same memory space for convenient addressing by the MCUcontroller.
- Memory interface block contains four pointers, two for data memory and two for coefficient memory.



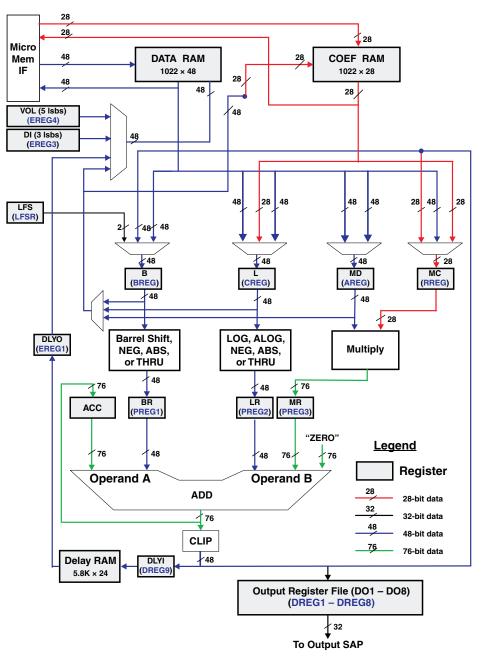


Figure 7-1. DSP Core Block Diagram



## 7.1 Audio Digital Signal Processor Core

The audio digital signal processor core arithmetic unit is a fixed-point computational engine consisting of an arithmetic unit and data and coefficient memory blocks. The audio processing structure, which can include mixers, multiplexers, volume, bass and treble, equalizers, dynamic range compression, or third-party algorithms, is running in the DAP. The 8051 MCUcontroller has access to DAP resources such as coefficient RAM and is able to support the DAP with certain tasks; for example, a volume ramp. The primary blocks of the audio DSP core are:

- 48-bit data path with 76-bit accumulator
- DSP controller
- Memory interface
- Coefficient RAM (1K×28)
- Data RAM 24-bit upper memory (1Kx24), 48-bit lower memory (768x48)
- Program RAM (3K×55)

The DAP is discussed in detail in the following sections.

## 7.2 DAP Instructions Set

Please see this information in the TAS3xxx Audio DSP Instruction Set Reference Guide



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## 7.3 DAP Data Word Structure

Figure 7-2 shows the data word structure of the DAP arithmetic unit. Eight bits of overhead or guard bits are provided at the upper end of the 48-bit DAP word, and 16 bits of computational precision or noise bits are provided at the lower end of the 48-bit word. The incoming digital audio words are all positioned with the most significant bit abutting the 8-bit overhead/guard boundary. The sign bit in bit 39 indicates that all incoming audio samples are treated as signed data samples The arithmetic engine is a 48-bit (25.23 format) processor consisting of a general-purpose 76-bit arithmetic logic unit and function-specific arithmetic blocks. Multiply operations (excluding the function-specific arithmetic blocks) always involve 48-bit DAP words and 28-bit coefficients (usually I<sup>2</sup>C programmable coefficients). If a group of products is to be added together, the 76-bit product of each multiplication is applied to a 76-bit adder, where a DSP-like multiply-accumulate (MAC) operation takes place. Biquad filter computations use the MAC operation to maintain precision in the intermediate computational stages.

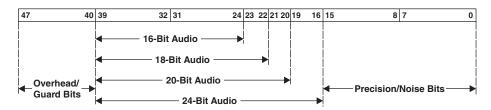


Figure 7-2. Arithmetic Unit Data Word Structure

To maximize the linear range of the 76-bit ALU, saturation logic is not used. In MAC computations, intermediate overflows are permitted, and it is assumed that subsequent terms in the computation flow correct the overflow condition (see Figure 7-3). The DAP memory banks include a dual port data RAM for storing intermediate results, a coefficient RAM, and a fixed program ROM. Only the coefficient RAM, assessable via the  $l^2C$  bus, is available to the user.

		1	0	1	1	0	1	1	1	(-73)	-	73
	+	1	   1 	0	0	1 	1 	0	   1 	(-51)	+ ·	-51
		1	0	0	0	0	   1	0	0	(-124)	-1	24
	+	1	<b>1</b>	0	1	0	0	1	<b>1</b>	(-45)	+ -	45
Rollover	[	0	1	0	1	0	1	1	1	(57)		57
	+	0	0	1	1	1	0	1	1	(59)	+	59
		1	0	0	   1	   0	0	1	0	(-110)	-1	10

Figure 7-3. DSP ALU Operation With Intermediate Overflow

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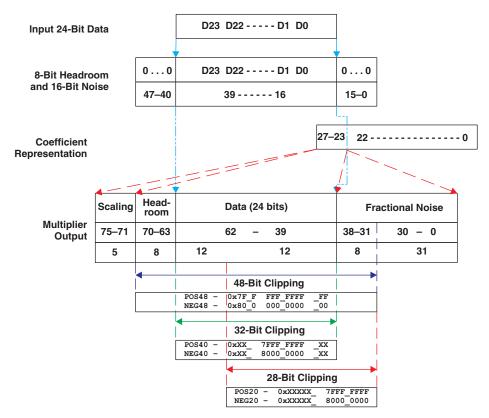


Figure 7-4. DAP Data-Path Data Representation



## 8 I<sup>2</sup>C Control Interface

The TAS3204 also two I<sup>2</sup>C interfaces that is compatible with the I<sup>2</sup>C bus protocol. The Master I<sup>2</sup>C supports 375-kbps data transfer rates for multiple 4-byte write and read operations (maximum is 20 bytes). The master I<sup>2</sup>C interface is used to load program and data from an external I<sup>2</sup>C EEPROM. The slave I<sup>2</sup>C interface supports both 100 kbps and 400 kbps data transfer rates for multiply 4 byte write and read operations (maximum 20 bytes). The slave I<sup>2</sup>C interface is used to program the registers of the device or to read the device status registers. Additionally, the slave I<sup>2</sup>C can be used to replace the information loaded by the I<sup>2</sup>C master interface.

## 8.1 General I<sup>2</sup>C Operations

The I<sup>2</sup>C bus employs two signals, SDA (serial data) and SCL (serial clock), to communicate between integrated circuits in a system. Data is transferred on the bus serially one bit at a time. The address and data are transferred in byte (8-bit) format with the most-significant bit (MSB) transferred first. In addition, each byte transferred on the bus is acknowledged by the receiving device with an acknowledge bit. Each transfer operation begins with the master device driving a start condition on the bus and ends with the master device driving a start condition on the bus and ends with the master device driving a start conditions. A HIGH-to-LOW transition on SDA while the clock is HIGH to indicate a start and stop conditions. A HIGH-to-LOW transition smust occur within the low time of the clock period. The master generates the 7-bit slave address and the read/write (R/W) bit to open communication with another device and then waits for an acknowledge condition. The slave holds SDA LOW during acknowledge clock period to indicate an acknowledgement. When this occurs, the master transmits the next byte of the sequence. Each device is addressed by a unique 7-bit slave address plus R/W bit (one byte). All compatible devices share the same signals via a bidirectional bus using a wired-AND connection. An external pullup resistor must be used for the SDA and SCL signals to set the HIGH level for the bus.

There is no limit on the number of bytes that can be transmitted between start and stop conditions. When the last word transfers, the master generates a stop condition to release the bus. Figure 8-1 shows the TAS3204 read and write operation sequences.

As shown in Figure 8-1, an  $I^2C$  read transaction requires that the master device first issue a write transaction to give the TAS3204 the subaddress to be used in the read transaction that follows. This subaddress assignment write transaction is then followed by the read transaction. For write transactions, the subaddress is supplied in the first byte of data written, and this byte is followed by the data to be written. For  $I^2C$  write transactions, the subaddress must always be included in the data written. There cannot be a separate write transaction to supply the subaddress, as was required for read transactions. If a subaddress-assignment-only write transaction is followed by a second write transaction supplying the data, erroneous behavior results. The first byte in the second write transaction is interpreted by the TAS3204 as another subaddress replacing the one previously written.

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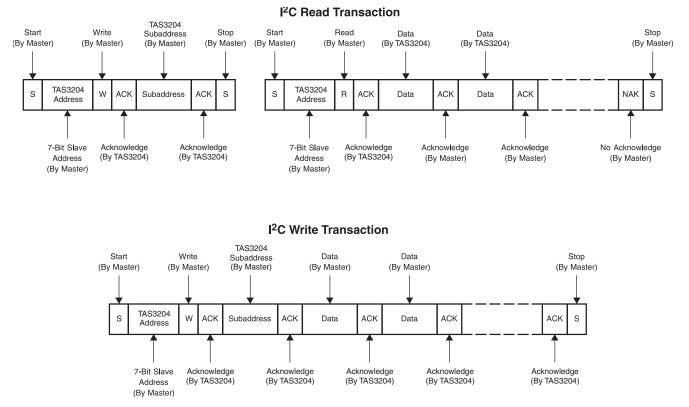


Figure 8-1. I<sup>2</sup>C Subaddress Access Protocol

## 8.2 I<sup>2</sup>C Master Interface

IIn the master mode, the I<sup>2</sup>C bus is used to:.

- Load the program and coefficient data
- MCU program memory
- MCU extended memory
- Audio DSP core program memory
- Audio DSP core coefficient memory
- Audio DSP core data memory

The TAS3204, when operating as an I<sup>2</sup>C master, can execute a complete download of any internal memory or any section of any internal memory without requiring any wait states.

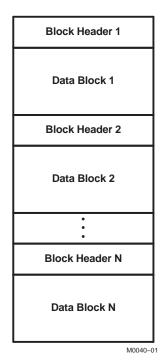
When the TAS3204 operates as an I<sup>2</sup>C master, the TAS3204 generates a repeated start without an intervening stop command while downloading program and memory data from EEPROM. When a repeated start is sent to the EEPROM in read mode, the EEPROM enters a sequential read mode to transfer large blocks of data quickly.

The first action of the TAS3204 as master is to transmit a start condition along with the device address of the I<sup>2</sup>C EEPROM with the read/write bit cleared (0) to indicate a write. The EEPROM acknowledges the address byte, and the TAS3204 sends a subaddress byte, which the EEPROM acknowledges. Most EEPROMs have at least 2-byte addresses and acknowledge as many as are appropriate. At this point, the EEPROM sends a last acknowledge and becomes a slave transmitter. The TAS3204 acknowledges each byte repeatedly to continue reading each data byte that is stored in memory.

The memory load information starts with reading the header and data information that starts at subaddress 0 of the EEPROM. This information must then be stored in sequential memory addresses with no intervening gaps. The data blocks are contiguous blocks of data that immediately follow the header locations.

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The TAS3204 memory data can be stored and loaded in (almost) any order. Additionally, this addressing scheme permits portions of the TAS3204 internal memories to be loaded.



### I<sup>2</sup>C EEPROM Memory Map

Figure 8-2. EEPROM Address Map

The TAS3204 sequentially reads EEPROM memory and loads its internal memory unless it does not find a valid memory header block, is not able to read the next memory location because the end of memory was reached, detects a checksum error, or reads an end-of-program header block. When it encounters an invalid header or read error, the TAS3204 attempts to read the header or memory location three times before it determines that it has an error. If the TAS3204 encounters a checksum error it attempts to reread the entire block of memory two more times before it determines that it has an error.

Once the MCU program memory has been loaded, it cannot be reloaded until the TAS3204 has been reset.

If an error is encountered, TAS3204 terminates its memory-load operation, loads the default configuration, and disables further master I<sup>2</sup>C bus operations.

If an end-of-program data block is read, the TAS3204 has completed the initial program load.

The I<sup>2</sup>C master mode uses the starting and ending I<sup>2</sup>C checksums to verify a proper EEPROM download. The first 16-bit data word received from the EEPROM, the I<sup>2</sup>C checksum at subaddress 0x00, is stored and compared against the 16-bit data word received for the last subaddress, the ending I<sup>2</sup>C checksum, and the checksum that is computed during the download. These three values must be equal. If the read and computed values do not match, the TAS3204 sets the memory read error bits in the status register and repeats the download from the EEPROM two more times. If the comparison check fails the third time, the TAS3204 sets the MCU program to the default value.

Table 8-1 shows the format of the EEPROM or other external memory load file. Each line of the file is a byte (in ASCII format). The checksum is the summation of all the bytes (with beginning and ending checksum fields = 00). The final checksum inserted into the checksum field is the lowest significant four bytes of the checksum.

Example:

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Given the following example MCU data or program block (must be a multiple of 4 bytes for these blocks): 0x10 0x20 0x30 0x40 0x50 0x60 0x70 0x80

The checksum = 0x10 + 0x20 + 0x30 + 0x30 + 0x40 + 0x50 + 0x60 + 0x70 + 0x80 = 0x240, so

the values put in the checksum fields are MS byte = 0x02 and LS byte = 0x40.

If the checksum is >FFFFh, then the 2-byte checksum field is the least-significant 2 bytes.

For example, if the checksum is 0x1D 45B6, the checksum field is MS byte = 0x45 and LS byte = 0xB6.

#### STARTING SIZE DATA BLOCK FORMAT NOTES BYTE 12-Byte Header Block Checksum code Most Significant Byte Checksum of bytes 2 through N + 12. 0 2 Bytes If this is a termination header, this value is 00 00 Checksum code Least Significant Byte Header ID byte 1 = 0x00 Must be 0x001F for the TAS3204 to load as part of 2 2 Bytes initialization. Any other value terminates the initialization Header ID byte 2 = 0x1F memory load sequence. 0x00 - MCU program memory - or - termination header 0x01 - MCU external data memory 0x02 - Audio DSP core program memory 0x03 – Audio DSP core coefficient memory 4 Memory to be loaded 1 Byte 0x04 - Audio DSP core data memory 0x05-06 - Audio DSP upper program memory 0x07 - Audio DSP Upper Coefficient Memory 0x08-FF - Reserved for future expansion 5 0x00 Reserved 1 Byte Start TAS3204 memory address Most Significant Byte 6 2 Bytes If this is a termination header, this value is 0000. Start TAS3204 memory address Least Significant Byte Total number of bytes transferred Most Significant Byte 12 + data bytes + last checksum bytes. If this is a 2 Bytes 8 termination header, this value is 0000. Total number of bytes transferred Least Significant Byte 10 0x00 1 Byte Unused 11 0x00 1 Byte Unused Data Block for MCU Program or Data Memory (Following 12-Byte Header) Data Byte 1 (LSB) Data Byte 2 12 4 Bytes MCU Bytes 1-4 Data Byte 3 Data byte 4 (MSB) Data byte 5 Data byte 6 16 MCU Bytes 5-8 4 Bytes Data byte 7 Data byte 8 Data byte 4x(Z - 1) + 1Data byte 4x(Z - 1) + 2N + 8 4 Bytes MCU Bytes N-N+4 Data byte 4x(Z - 1) + 3Data byte 4x(Z - 1) + 4 = N

## Table 8-1. TAS3204 Master I<sup>2</sup>C Memory Block Structures



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Table 8-1. TAS3204 Master I<sup>2</sup>C Memory Block Structures (continued)

STARTING BYTE	DATA BLOCK FORMAT	SIZE	NOTES		
	0x00				
N + 12	0x00	4 Bytes	Dependence of the star 2 through N + 11		
N + 12	Checksum code MS Byte	4 bytes	Repeated checksum bytes 2 through N + 11		
	Checksum code LS Byte				
Data Block for Au	dio DSP Core Coefficient Memory (Foll	owing 12-Byte H	leader)		
	Data byte 1 (LS byte)		Coefficient word 1 (valid data in Bit 27-Bit 0) Bit 7-Bit 0		
12	Data byte 2	4 bytes	Bit 15–Bit 8		
12	Data byte 3	4 bytes	Bit 23–Bit 16		
	Data byte 4 (MS byte)		Bit 31–Bit 24		
	Data byte 5				
16	Data byte 6	1 hutaa	Coofficient word 2		
16	Data byte 7	4 bytes	Coefficient word 2		
	Data byte 8				
	:				
	Data byte 4×(Z − 1) + 1				
	Data byte $4x(Z - 1) + 2$	1 hutaa	Coefficient word 7		
N + 8	Data byte $4x(Z - 1) + 3$	4 bytes	Coefficient word Z		
	Data byte $4x(Z - 1) + 4 = N$				
	0x00				
N - 40	0x00	4 hudaa	Demosterial characteristics of the such N + 44		
N + 12	Checksum code MS byte	4 bytes	Repeated checksum bytes 2 through N + 11		
	Checksum code LS byte				
Data Block for Au	dio DSP Core Data Memory (Following	12-Byte Header			
	Data byte 1 (LS byte)		Data word 1 Bit 7–Bit 0		
	Data byte 2		Bit 15–Bit 8		
12	Data byte 3	6 hutaa	Bit 23–Bit 16		
12	Data byte 4	6 bytes	Bit 31–Bit 24		
	Data byte 5		Bit 39–Bit 32		
	Data byte 6 (MS byte)		Bit 47–Bit 40		
	Data byte 7				
	Data byte 8				
18	Data byte 9	6 bytee	Dete 2		
10	Data byte 10	6 bytes	Data 2		
	Data byte 11				
	Data byte 12				
	:				
	Data byte 6×(Z – 1) + 1				
	Data byte $6x(Z - 1) + 2$				
NIC	Data byte $6x(Z - 1) + 3$	6 hite-	Data Z		
N + 6	Data byte $6 \times (Z - 1) + 4$	6 bytes	Data Z		
	Data byte $6 \times (Z - 1) + 5$				

## Table 8-1. TAS3204 Master I<sup>2</sup>C Memory Block Structures (continued)

STARTING BYTE	DATA BLOCK FORMAT	SIZE	NOTES		
	0x00				
	0x00				
N 40	0x00	<u>.</u>			
N + 12	0x00	6 bytes	Repeated checksum bytes 2 through N + 11		
	Checksum code MS byte				
	Checksum code LS byte				
Data Block for Au	udio DSP Core Program Memory (Following	12-Byte Hea	ader)		
	Program byte 1 (LS byte)		Program word 1 (valid data in Bit 53–Bit 0) Bit 7–Bit 0		
	Program byte 2		Bit 15–D8		
	Program byte 3		Bit 23–Bit 16		
12	Program byte 4	7 bytes	Bit 31–Bit 24		
	Program byte 5		Bit 39–Bit 32		
	Program byte 6		Bit 47–Bit 40		
	Program byte 7 (MS byte)	6 bytes       Repeated checksum bytes 2 through N + 11         ollowing 12-Byte Header)         ollowing 12-Byte Header)         Program word 1 (valid data in Bit 53-Bit 0) Bit         Bit 15-D8         Bit 23-Bit 16         Bit 31-Bit 24         Bit 39-Bit 32         Bit 55-Bit 48         7 bytes         7 bytes         7 bytes         7 bytes         7 bytes         Program word 2         7 bytes         Repeated checksum bytes 2 through N + 11         Hellock	Bit 55–Bit 48		
	Program byte 8				
	Program byte 9				
	Program byte 10				
19	Program byte 11	7 bytes	Program word 2		
	Program byte 12				
	Program byte 14				
	Program byte 15				
	:				
	Program byte 7×(Z – 1) + 1				
	Program byte $7 \times (Z - 1) + 2$				
	Program byte $7 \times (Z - 1) + 3$				
N + 5	Program byte $7 \times (Z - 1) + 4$	7 bytes	Program word Z		
	Program byte $7 \times (Z - 1) + 5$				
	Program byte $7 \times (Z - 1) + 6$				
	Program byte $7 \times (Z - 1) + 7 = N$				
	0x00				
	0x00				
	0x00				
N + 12	0x00	7 bytes	Repeated checksum bytes 2 through N + 11		
	0x00	,			
	Checksum code MS byte				
	Checksum code LS byte				
20-Byte Terminat	ion Block (Last Block of Entire Load Block)				
-	0x00				
B <sub>LAST</sub> – 19	0x00	2 bytes	First 2 bytes of termination block are always 0x0000.		
	0x00				
B <sub>LAST</sub> – 17	0x1F	2 bytes	Second 2 bytes are always 0x001F.		
B <sub>LAST</sub> – 15	0x00	1 bvte			
B <sub>LAST</sub> – 14	0x00		-		
	:		Last 16 bytes must each be 0x00.		
B <sub>LAST</sub>	0x00	1 byte	-		

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## 8.3 I<sup>2</sup>C Slave Mode Operation

In the slave mode, the I<sup>2</sup>C bus is used to:

- Load the program and coefficient data
- MCU program memory
- MCU extended memory
- Audio DSP core program memory
- Audio DSP core coefficient memory
- Audio DSP core data memory
- Update coefficient and other control values
- Read status flags

The coefficient download operation in slave mode can be used to replace the  $I^2C$  master-mode EEPROM download. The TAS3204 supports both random and sequential  $I^2C$  transactions. The TAS3204  $I^2C$  slave address is 0b011010xy, where the first six bits are the TAS3204 device address and bit x is CS0, which is set by the TAS3204 internal MCU at power up. Bit y is the R/W bit. The pulldown resistance of CS0 creates a default 00 address when no connection is made to the pin. Table 6-1 and Table 8-3 show all the legal addresses for  $I^2C$  slave and master modes.

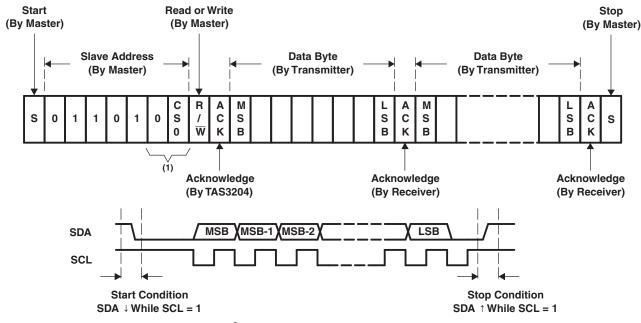
Once the MCU program memory has been loaded, it cannot be updated until the TAS3204 has been reset.

The master and slave modes do not operate simultaneously.

When acting as an I<sup>2</sup>C slave, the data transfer rate is determined by the master device on the bus.

The I<sup>2</sup>C communication protocol for the I<sup>2</sup>C slave mode is shown in Figure 8-3.

The I<sup>2</sup>C communication protocol for the I<sup>2</sup>C slave mode is shown in Figure 8-3.





The number of data bytes plus the two bytes checksum must be evenly divisible by the word size. The size field is equal to (header + payload + end checksum).

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The checksum is contained in the last two data transfer bytes. These are bytes 7 and 8. On single word transfers (DAP data, DAP instruction), the checksum is always contained in a 8 byte frame that follows the last data word, last two bytes. For multiword data register transfers data (MCU Program RAM, MCU External Data RAM, and DAP Coefficient RAM), the checksum is included in the same byte transfer as data. To meet the requirement above, the number of words that are transferred contain modulo 8 + 6 in the case of MCU program and data memory, and modulo 2 + 1 in the case of coefficient memory. When the slave I<sup>2</sup>C download is used to replace or update sections of MCU program, MCU data, or DAP coefficient memory, it is necessary to take these transfer size restrictions into consideration when determining program, data, and coefficient placements.

The multi word transfers always store first word on the bus at a lower RAM address and increment such that the last word in the transfer is stored with the highest target RAM address. Consecutive I<sup>2</sup>C frame transfers increment target address such that the data in the last transfer is last in target memory address space.

When the first I<sup>2</sup>C slave download register is written by the system controller, the TAS3204 updates the status register by setting a error bit to indicate an error for the memory type that is being loaded. This error bit is reset when the operation complete and a valid checksum has been received. For example when the MCU program memory is being loaded, the TAS3204 sets a MCU program memory error indication in the status register at the start of the sequence. When the last byte of the MCU program memory and checksum is received, the TAS3204 clears the MCU program memory error indication. This enables the TAS3204 to preserve any error status indications that occur as a result of incomplete transfers of data/ checksum error during a series of data and program memory load operations.

The checksum is always contained in the last two bytes of the data block. The I<sup>2</sup>C slave download is terminated when a termination header with a zero-length byte-count file is received.

The status register always reflects status of EEPROM boot attempts, unless the user writes to the slave control register. A write to the slave boot control register causes the EEPROM status register to reflect slave boot attempt status.

### NOTE

Once the MCU program memory has been loaded, further updates to this memory are prohibited until the device is reset. The TAS3204  $I^2C$  block does respond to the broadcast address (0x00).

Figure x.x shows the block format of the  $I^2C$  slave Interface. or other external memory load file. Each line of the file is a byte (in ASCII format). The checksum is the summation of all the bytes (with beginning and ending checksum fields = 00). The final checksum inserted into the checksum field is the lowest significant four bytes of the checksum

Base Address	CS0	R/W	Slave Address
0110 10	0	0	0x68
0110 10	0	1	0x69
0110 10	1	0	0x6A
0110 10	1	1	0x6B

## Table 8-2. Slave Addresses

se Address	CS0	R/W	Master Address
1010 00	0	0	0xA0
1010 00	0	1	0xA1
1010 00	1	0	0xA2
1010 00	1	1	0xA3
	1010 00 1010 00	1010 00         0           1010 00         0           1010 00         1	1010 00         0         0           1010 00         0         1           1010 00         1         0

Table 8-3. Master Addresses

The following is an example use of the  $l^2C$  master address to access an external EEPROM. The TAS3204 can address up to two EEPROMs depending on the state of CS0. Initially, the TAS3204 comes up in  $l^2C$  master mode. If it finds a memory such as the 24C512 EEPROM, it reads the headers and data as previously described. In this  $l^2C$  master mode, the TAS3204 addresses the EEPROMs as shown in Table 8-4 and Table 8-5.

Table 8-4. EEPROM Address I<sup>2</sup>C TAS3204 Master Mode = 0xA1/A0

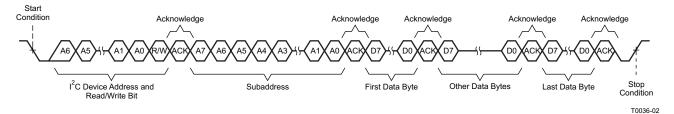
MSB					A0 (EEPROM)	CS0	R/W
1	0	1	0	0	0	0	1/0

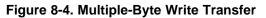
## Table 8-5. EEPROM Address I<sup>2</sup>C TAS3204 Master Mode = 0xA3/A2

MSB					A0 (EEPROM)	CS0	R/W
1	0	1	0	0	0	1	1/0

## 8.3.1 Multiple-Byte Write

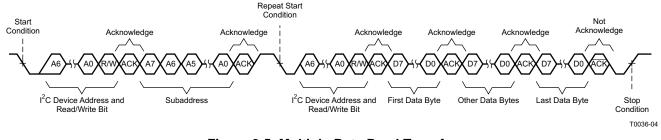
Multiple data bytes are transmitted by the master device to slave as shown in Figure 8-4. After receiving each data byte, the TAS3204 responds with an acknowledge bit.





## 8.3.2 Multiple-Byte Read

Multiple data bytes are transmitted by the TAS3204 to the master device as shown in Figure 8-5. Except for the last data byte, the master device responds with an acknowledge bit after receiving each data byte.



## Figure 8-5. Multiple-Byte Read Transfer



## Random I<sup>2</sup>C Transactions

Supplying a subaddress for each subaddress transaction is referred to as random  $I^2C$  addressing. For random  $I^2C$  read commands, the TAS3204 responds with data, a byte at a time, starting at the subaddress assigned, as long as the master device continues to respond with acknowledges. If a given subaddress does not use all 32 bits, the unused bits are read as logic 0.  $I^2C$  write commands, however, are treated in accordance with the data assignment for that address space. If a write command is received for a mixer subaddress, for example, the TAS3204 expects to see five 32-bit words. If fewer than five data words have been received when a stop command (or another start command) is received, the data received is discarded.

## Sequential I<sup>2</sup>C Transactions

The TAS3204 also supports sequential I<sup>2</sup>C addressing. For write transactions, if a subaddress is issued followed by data for that subaddress and the 15 subaddresses that follow, a sequential I<sup>2</sup>C write transaction has taken place, and the data for all 16 subaddresses is successfully received by the TAS3204. For I<sup>2</sup>C sequential write transactions, the subaddress then serves as the start address and the amount of data subsequently transmitted, before a stop or start is transmitted, determines how many subaddresses are written to. As was true for random addressing, sequential addressing requires that a complete set of data be transmitted. If only a partial set of data is written to the last subaddress, the data for the last subaddress is discarded. However, all other data written is accepted; just the incomplete data is discarded.

Sequential read transactions do not have restrictions on outputting only complete subaddress data sets.

If the master does not issue enough data-received acknowledges to receive all the data for a given subaddress, the master device simply does not receive all the data.

If the master device issues more data-received acknowledges than required to receive the data for a given subaddress, the master device simply receives complete or partial sets of data, depending on how many data-received acknowledges are issued from the subaddress(es) that follow. I<sup>2</sup>C read transactions, both sequential and random, can impose wait states.



## 9 TAS3204 Control Pins

## 9.1 Reset (RESET) - Power-Up Sequence

The RESET pin is an asynchronous control signal that restores all TAS3204 components to the default configuration. When a reset occurs, the audio DSP core is put into an idle state and the 8051 starts initialization. A valid XTAL\_IN must be present when clearing the RESET pin to initiate a device reset. A reset can be initiated by applying a logic 0 on RESET.

As long as  $\overline{\text{RESET}}$  is held LOW, the device is in the reset state. During reset, all I<sup>2</sup>C and serial data bus operations are ignored. The I<sup>2</sup>C interface SCL and SDA lines go into a high-impedance state and remain in that state until device initialization has completed.

The rising edge of the reset pulse begins the initialization housekeeping functions of clearing memory and setting the default register values. Once these are complete, the TAS3204 enables its master I<sup>2</sup>C interface and disables its slave I<sup>2</sup>C interface and startes the boot sequence.

Using the master interface, the TAS3204 automatically tests to see if an external  $I^2C$  EEPROM is at address "1010x". The value x can be chip selects, other information, or don't care, depending on the EEPROM selected.

If a memory is present and it contains the correct header information and one or more blocks of program/memory data, the TAS3204 begins to load the program, coefficient and/or data memories from the external EEPROM. The download is considered complete when an end of program header is read by the TAS3204. At this point, the TAS3204 disables the master I<sup>2</sup>C interface, enable the slave I<sup>2</sup>C interface, and start normal operation. After a successful download, the MCU program counter is reset, and the downloaded MCU and DAP application firmware controls execution.

If no external EEPROM is present or if an error occurs during the EEPROM read, TAS3204 disables the master  $I^2C$  interface and enables the slave  $I^2C$  interface initialization to load the slave default configuration. In this default configuration, the TAS3204 streams audio from input to output if GPIO1 is asserted LOW; if the GPIO1 pin is asserted HIGH, the ADC and the DAC are muted.

On power up, it is recommended that the TAS3204 RESET be held LOW until DVDD has reached 3.3 V. This can be done by programming the system controller or by using an external RC delay circuit. The 1-k $\Omega$  and 1- $\mu$ F values provide a delay of approximately 200  $\mu$ s. The values of R and C can be adjusted to provide other delay values as necessary.

Note: The master and slave interfaces do not operate simultaneously.

## 9.2 Voltage Regulator Enable (VREG\_EN)

Setting the VREG\_EN high shuts down all voltage regulators in the device. Internal register settings are lost in this power down mode. A full power-up/reset/program-load sequence must be completed before the device is operational.

## 9.3 Power Down (PDN)

The TAS3204 supports a number of power-down modes.

PDN can be used to put the device into power saving standby mode. PDN is user-firmware definable. Its default configuration is to stop all clocks, power down all analog circuitry, and ramp down volume for all digital inputs. This mode is used to minimize power consumption while preserving register settings. If there is no EEPROM or if the EEPROM has an invalid image–i.e., an unsuccessful boot from the EEPROM–and PDN is pulled low, the TAS3204 is in powerdown mode. After a successful boot, PDN is defined by the boot code.

Individual power down DAC and ADC – Each stereo DAC and ADC can be powered down individually. To avoid audible artifacts at the outputs, the sequences defined in the TI document *TAS3108/TAS3108IA Firmware Programmer's Guide* (<u>SLEU067</u>) must be followed. The control signals for these operations are defined as ESFR. The feature is made available to the board controller via the I<sup>2</sup>C interface.



Power down of analog reference – The analog reference can be powered down if all DAC and ADC are powered down. This operation is handled by the device controller through the ESFRs, and is made available to the board controller via the  $l^2C$  interface.

## 9.4 I<sup>2</sup>C Bus Control (CS0)

The TAS3204 has a control to specify the slave and master I<sup>2</sup>C address. This control permits up to two TAS3204 devices to be placed in a system without external logic. GPIO pins are level sensitive. They are not edge triggered.

See Section 8.3 for a complete description of this pin.

## 9.5 Programmable I/O (GPIO)

The TAS3204 has four GPIO pins and two general purpose input pins that are 8051 firmware programmable.

GPIO1 and GPIO2 pins are single function I/O pins. Upon power up, GPIO1 is an input. If there is an unsuccessful boot and GPIO1 is pulled high externally, the DAC output is disabled. If there is an unsuccessful boot and the GPIO1 is pulled low externally, the DAC output is enabled. If there is a successful boot, GPIO1 is pulled low by the internal MCU, and its function is defined by the boot code in the EEPROM.

GPIO3 and GPIO4 pins are dual function I/O pins. These pins can be used as SDIN1 and SDIN2 respectively.

Mute and power down functions have to be programmed in the EEPROM boot code. These are general-purpose input pins and can be programmed for functions other than mute and power down.

## 9.5.1 No EEPROM is Present or a Memory Error Occurs

Following reset or power-up initialization with the EEPROM not present or if a memory error occurs, the TAS3204 is in one of two modes, depending on the setting of GPIO1.

## • GPIO1 is logic HIGH

With GPIO1 held HIGH during initialization, the TAS3204 comes up in the default configuration with the serial data outputs not active. Once the TAS3204 has completed the default initialization procedure, after the status register is updated and the  $I^2C$  slave interface is enabled, then GPIO1 is an output and is driven LOW. Following the HIGH-to-LOW transition of the GPIO pin, the system controller can access the TAS3204 through the  $I^2C$  interface and read the status register to determine the load status.

If a memory-read error occurs, the TAS3204 reports the error in the status register ( $I^2C$  subaddress 0x02).

## • GPIO1 is logic LOW

With GPIO1 held LOW during initialization, the TAS3204 comes up in an I/O test configuration. In this case, once the TAS3204 completes its default test initialization procedure, the status register is updated, the I<sup>2</sup>C slave interface is enabled, and the TAS3204 streams audio unaltered from input to output as SDIN1 to SDOUT1, SDIN2 to SDOUT2, etc.

In this configuration, GPIO1 is an output signal that is driven LOW. If the external logic is no longer driving GPIO1 low after the load has completed (~100 ms following a reset if no EEPROM is present), the state of GPIO1 can be observed.

Then the system controller can access the TAS3204 through the  $I^2C$  interface and read the status register to determine the load status.

If the GPIO1 state is not observed, the only indication that the device has completed its initialization procedure is the fact that the TAS3204 streams audio and the  $I^2C$  slave interface has been enabled.



# 9.5.2 GPIO Pin Function After Device Is Programmed

Once the TAS3204 has been programmed, either through a successful boot load or via slave I<sup>2</sup>C download, the operation of GPIO can be programmed to be an input and/or output.



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# 10 Algorithm and Software Development Tools for TAS3204

The TAS3204 algorithm and software development tool set is a combination of classical development tools and graphical development tools. The tool set is used to build, debug, and execute programs in both the audio DSP and 8051 sections of the TAS3204.

Classical development tooling includes text editors, compilers, assemblers, simulators, and source-level debuggers. The 8051 can be programmed exclusively in ANSI C.

The 8051 tool set is an off-the-shelf tool set, with modifications as specified in this document. The 8051 tool set is a complete environment with an IDE, editor, compiler, debugger, and simulator.

The audio DSP core is programmed exclusively in assembly. The audio DSP tool set is a complete environment with an IDE, context-sensitive editor, assembler, and simulator/debugger.

Graphical development tooling provides a means of programming the audio DSP core and 8051 through a graphical drag-and-drop interface using modular audio software components from a component library. The graphical tooling produces audio DSP assembly and 8051 ANSI C code as well as coefficients and data. The classical tools can also be used to produce the executable code.

In addition to building applications, the tool set supports the debug and execution of audio DSP and 8051 code on both simulators and EVM hardware.



# 11 Electrical Specifications

### 11.1 Absolute Maximum Ratings<sup>(1)</sup>

over operating temperature range (unless otherwise noted)

DVDD	Digital supply voltage range		–0.5 V to 3.8 V
AVDD	Analog supply voltage rang	e	–0.5 V to 3.8 V
V	Input voltage renge	3.3-V TTL	–0.5 V to DVDD + 0.5 V
VI	Input voltage range	1.8 V LVCMOS (XTLI)	–0.5 V to 2.3 V
	3.3 V TTL		-0.5 V to DVDD + 0.5 V
Vo	Output voltage range	1.8 V LVCMOS (XTLO)	-0.5 V to 2.3 V <sup>(2)</sup>
I <sub>IK</sub>	Input clamp current (V <sub>I</sub> < 0	or V <sub>I</sub> > DVDD)	±20 μΑ
I <sub>OK</sub>	Output clamp current (V <sub>O</sub> <	0 or $V_0 > DVDD$ )	±20 μΑ
T <sub>A</sub>	Operating free-air temperat	ure range	0°C to 70°C
T <sub>stg</sub>	Storage temperature range		–65°C to 150°C

Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings (1) only, and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

Pin XTAL\_OUT is the only TAS3204 output that is derived from the internal 1.8-V logic supply. The absolute maximum rating listed is for (2) reference; only a crystal should be connected to XTAL\_OUT. Note:

VR\_ANA is derived from TAS3204 internal 1.8-V voltage regulator. This terminal must not be used to power external devices. VR\_DIG is derived from TAS3204 internal 1.8-V voltage regulator. This terminal must not be used to power external devices.

VR\_PLL is derived from TAS3204 internal 1.8-V voltage regulator. This terminal must not be used to power external devices.

### 11.2 Package Dissipation Ratings

Package Type Pin Count Package	T <sub>A</sub> ≤ 25°C	Derating Factor	T <sub>A</sub> = 70°C		
Package Type	Pin Count	Package Designator	Power Rating (mW)	Above T <sub>A</sub> = 25°C (mW/°C)	Power Rating (mW)
TQFP	64	PAG	1869	23.36	818

### 11.3 Recommended Operating Conditions

			MIN	NOM	MAX	UNIT
DVDD	Digital supply voltage		3	3.3	3.6	V
AVDD	Analog supply voltage		3	3.3	3.6	V
V	Lich lovel input veltage	3.3 V TTL	2			V
V <sub>IH</sub>	H High-level input voltage	1.8 V LVCMOS (XTL_IN)	1.2			v
V	Low-level input voltage	3.3 V TTL			0.8	V
VIL	Low-level input voltage	1.8 V LVCMOS (XTL_IN)			0.5	
T <sub>A</sub>	Operating ambient air temperature		0	25	70	°C
TJ	Operating junction temperature		0		105	°C
	Analog differential input			2		V <sub>RMS</sub>
	Analog output load	Resistance		10		kΩ
	Operating junction temperature	Capacitance		100		pF

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### **11.4 Electrical Characteristics**

over recommended operating conditions (unless otherwise noted)

	PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
		3.3-V TTL	$I_{OH} = -4 \text{ mA}$	2.4			
V <sub>OH</sub>	High-level output voltage	1.8-V LVCMOS (XTL_OUT)	I <sub>OH</sub> = -0.55 mA	1.44			V
		3.3-V TTL	$I_{OL} = 4 \text{ mA}$			0.5	
V <sub>OL</sub>	Low-level output voltage	1.8-V LVCMOS (XTL_OUT)	I <sub>OL</sub> = 0.75 mA			0.4	V
I <sub>OZ</sub>	High-impedance output current	3.3-V TTL	$V_{I} = V_{IL}$			±20	μA
		3.3-V TTL	$V_I = V_{IL}$			±20	
IIL	Low-level input current	1.8-V LVCMOS (XTL_IN)	$V_{I} = V_{IL}$			±20	μA
		3.3-V TTL	$V_{I} = V_{IH}$			±20	
I <sub>IH</sub>	High-level input current	1.8-V LVCMOS (XTL_IN)	$V_{I} = V_{IH}$			±20	μA
I <sub>DVDD</sub>	Digital supply current	Normal operation	MCLK_IN = 24.576 MHz, LRCLK = 48 kHz		130		mA
I <sub>AVDD</sub>	Analog supply current	Normal operation	MCLK_IN = 24.576 MHz, LRCLK = 48 kHz		60		mA
Power		Normal operation	MCLK_IN = 24.576 MHz, LRCLK = 48 kHz		627		mW
Dissipation	Digital and analog supply current	Otomalhu, maada	With voltage regulators on		23		mW
(Total)		Standby mode	With voltage regulators off		825		μW
		Reset mode			20		mW
VR_ANA	Internal voltage regulator – analog			1.6	1.8	1.98	V
VR_PLL	Internal voltage regulator – PLL			1.6	1.8	1.98	V
VR_DIG	Internal voltage regulator – digital			1.6	1.8	1.98	V

# 11.5 Audio Specifications

 $T_A = 25$ °C, AVDD = 3.3 V, DVDD = 3.3 V, Fs = 48 kHz, 1-kHz sine wave full scale, over operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN TYP	MAX	UNIT
Overall performance:	Dynamic range	Evaluation module. A-weighted, -60 dB with respect to full scale	100		dB
input ADC – DAP – DAC – line out	ance: Dynamic range –6 THD+N Ev res Dynamic range A full THD+N –4 Crosstalk Or Or Crosstalk Or Oti Power supply rejection ratio 1 k Input resistance Input capacitance Pass band edge Pass band ripple	Evaluation module. –3 dB with respect to full scale	101		dB
	Dynamic range	A-weighted, –60 dB with respect to full scale.	102	100 101	dB
ADC section	THD+N	-4 dB with respect to full scale.	93		dB
	Crosstalk	One channel = $-3 \text{ dB}$ ; Other channel = $0 \text{ V}$	84		dB
	Power supply rejection ratio	1 kHz, 100 mVpp on AVDD	57		dB
	Input resistance		20		kΩ
	Input capacitance		10		pF
	Pass band edge		0.45Fs		Hz
	Pass band ripple		±0.01		dB
ADC decimation filter	Stop band edge		0.55Fs		Hz
	Stop band attenuation		100		dB
	Group delay		37÷Fs		Sec



#### Audio Specifications (continued)

 $T_A = 25$ °C, AVDD = 3.3 V, DVDD = 3.3 V, Fs = 48 kHz, 1-kHz sine wave full scale, over operating free-air temperature range (unless otherwise noted)

F	PARAMETER		TEST CONDITIONS	MIN TYP	MAX	UNIT
	Differential ful voltage	l scale output		2		V <sub>RMS</sub>
	Dynamic rang	e	A-weighted, -60 dB with respect to full scale	105		dB
AC section Differentia voltage Dynamic THD+N Crosstalk Power su DC offset Pass ban Pass ban Pass ban Stop band Stop band	THD+N		-1-dBFS input, 0-dB gain	95		dB
DAC section		DAC to ADC	One channel –3 dBFS; Other channel 0 V	84		dB
Differential full scale out voltage Dynamic range THD+N DAC section Crosstalk ADC t DAC t	ADC to DAC	One channel –3 dB; Other channel 0 V	84		dB	
		DAC to DAC	One channel –3 dBFS; Other channel 0 V	84		dB
	Power supply	rejection ratio	1 kHz, 100 mVpp on AVDD	56		dB
	DC offset		With respect to V <sub>REF</sub>			mV
	Pass band ed	ge		0.45Fs		Hz
	Pass band rip	ple		±0.06		dB
DAC interpolation filter	Transition bar	nd		1.45 Fs to 0.55Fs		Hz
•	Stop band edg	ge		7.4Fs		Hz
	Stop band atte	enuation		-65		dB
	Filter group de	elay		21÷Fs		Sec

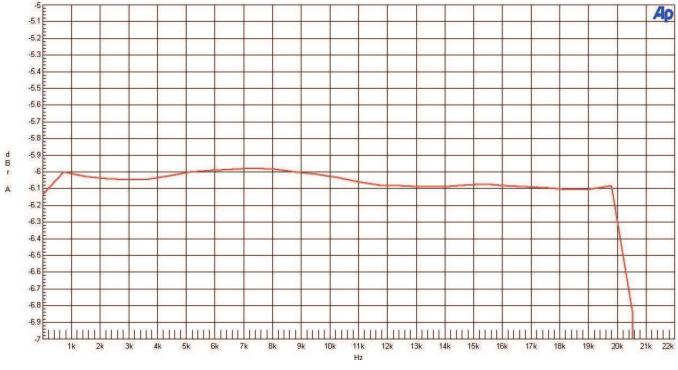
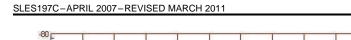


Figure 11-1. Frequency Response (ADC-DAC)

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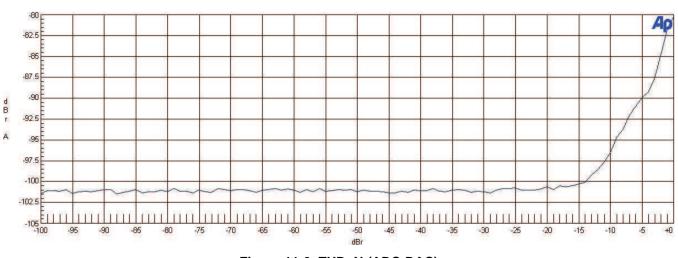


Figure 11-2. THD+N (ADC-DAC)



### **11.6 Timing Characteristics**

The following sections describe the timing characteristics of the TAS3204.

#### 11.7 **Master Clock**

over recommended operating conditions (unless otherwise noted)

	PARAMETE	R	TEST CONDITIONS	MIN	ТҮР	МАХ	UNIT
f <sub>(XTAL_IN)</sub>	Frequency, XTAL_IN (1/ t <sub>c(1)</sub> )		See (1)		512Fs		Hz
t <sub>c(1)</sub>	Cycle time, XTAL_IN				1÷512Fs		Sec
f <sub>(MCLK_IN)</sub>	Frequency, MCLK_IN (1/ t <sub>c(2)</sub> )				512Fs		Hz
t <sub>w(MCLK_IN)</sub>	Pulse duration, MCLK_IN high	ו	See (2)	0.4 t <sub>c(2)</sub>	0.5 t <sub>c(2)</sub>	0.6 t <sub>c(2)</sub>	ns
	Crystal frequency deviation					50	ppm
f <sub>(MCLKO)</sub>	Frequency, MCLKO (1/ t <sub>c(3)</sub> )				256Fs		Hz
t <sub>r(MCLKO)</sub>	Rise time, MCLKO		C <sub>L</sub> = 30 pF			15	ns
t <sub>f(MCLKO)</sub>	Fall time, MCLKO		C <sub>L</sub> = 30 pF			15	ns
t <sub>w(MCLK_IN)</sub>	Pulse duration, MCLKO high		See <sup>(3)</sup>		H <sub>MCLKO</sub>		ns
		XTAL_IN master clock source			80		ps
		MCLK_IN master clock source	See (4)				ps
	Delay time, MCLK_IN rising	MCLKO = MCLK_IN	See <sup>(5)</sup>			20	ns
t <sub>d(MI-MO)</sub>	edge to MCLKO rising edge	MCLKO < MCLK_IN	See (5) (6)			20	ns

Duty cycle is 50/50. (1)

(2)

Period of MCLK\_IN =  $T_{MCLK\_IN} = 1/f_{MCLK\_IN}$ H<sub>MCLKO</sub> = 1/(2 × MCLKO). MCLKO has the same duty cycle as MCLK\_IN when MCLKO = MCLK\_IN. When MCLKO = 0.5 MCLK\_IN or 0.25 MCLK\_IN, the duty cycle of MCLKO is typically 50%. (3)

When MCLKO is derived from MCLK\_IN, MCLKO jitter = MCLK\_IN jitter (4)

- Only applies when MCLK\_IN is selected as master source clock (5)
- (6) Also applies to MCLKO falling edge when MCLKO = MCLK\_IN/2 or MCLK\_IN/4

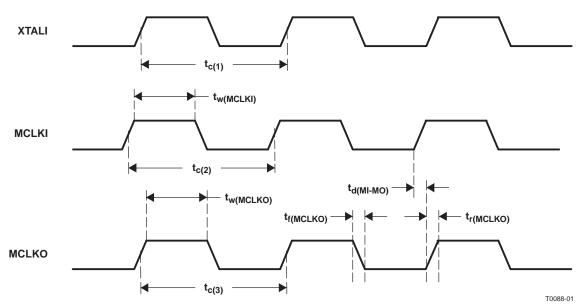


Figure 11-3. Master Clock Signal Timing Waveforms

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### 11.8 Serial Audio Port, Slave Mode

over recommended operating conditions (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	ТҮР	МАХ	UNIT
f <sub>LRCLK</sub>	Frequency, LRCLK (f <sub>S</sub> )				48	kHz
t <sub>w(SCLKIN)</sub>	Pulse duration, SCLKIN high	See <sup>(1)</sup>	0.4 t <sub>c(SCLKIN)</sub>	0.5 t <sub>c(SCLKIN)</sub>	0.6 t <sub>c(SCLKIN)</sub>	ns
f <sub>SCLKIN</sub>	Frequency, SCLKIN	See <sup>(2)</sup>		64 F <sub>S</sub>		MHz
t <sub>pBit 1</sub>	Propagation delay, SCLKIN falling edge to SDOUT				16	ns
t <sub>su1</sub>	Setup time, LRCLK to SCLKIN rising edge		10			ns
t <sub>h1</sub>	Hold time, LRCLK from SCLKIN rising edge		5			ns
t <sub>su2</sub>	Setup time, SDIN to SCLKIN rising edge		10			ns
t <sub>h2</sub>	Hold time, SDIN from SCLKIN rising edge		5			ns
t <sub>pBit 2</sub>	Propagation delay, SCLKIN falling edge to SCLKOUT2 falling edge				15	ns

(1) Period of SCLKIN =  $T_{SCLKIN} = 1/f_{SCLKIN}$ 

(2) Duty cycle is 50/50.

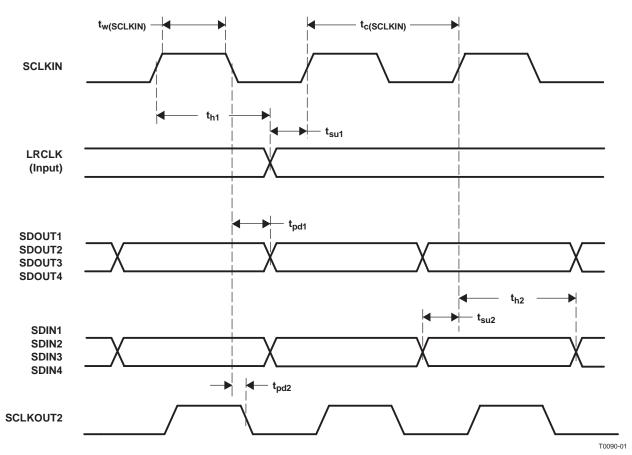


Figure 11-4. Serial Audio Port Slave Mode Timing Waveforms



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# 11.9 Serial Audio Port Master Mode Signals (TAS3204)

over recommended operating conditions (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
f <sub>(LRCLK)</sub>	Frequency LRCLK	C <sub>L</sub> = 30 pF		48		kHz
t <sub>r(LRCLK)</sub>	Rise time, LRCLK <sup>(1)</sup>	C <sub>L</sub> = 30 pF			12	ns
t <sub>f(LRCLK)</sub>	Fall time, LRCLK <sup>(1)</sup>	Duty cycle is 50/50			12	ns
f <sub>(SCLKOUT)</sub>	Frequency, SCLKOUT	C <sub>L</sub> = 30 pF		64F <sub>S</sub>		MHz
t <sub>r(SCLKOUT)</sub>	Rise time, SCLKOUT	C <sub>L</sub> = 30 pF			12	ns
t <sub>f(SCLKOUT)</sub>	Fall time, SCLKOUT	C <sub>L</sub> = 30 pF			12	ns
t <sub>pBit</sub> 1(SCLKOUT)	Propagation delay, SCLKOUT falling edge to LRCLK edge				5	ns
t <sub>pBit 2</sub>	Propagation delay, SCLKOUT falling edge to SDOUT1-2				5	ns
t <sub>su</sub>	Setup time, SDIN to SCLKOUT rising edge		25			ns
t <sub>h</sub>	Hold time, SDIN from SCLKOUT rising edge		30			ns

(1) Rise time and fall time measured from 20% to 80% of maximum height of waveform.

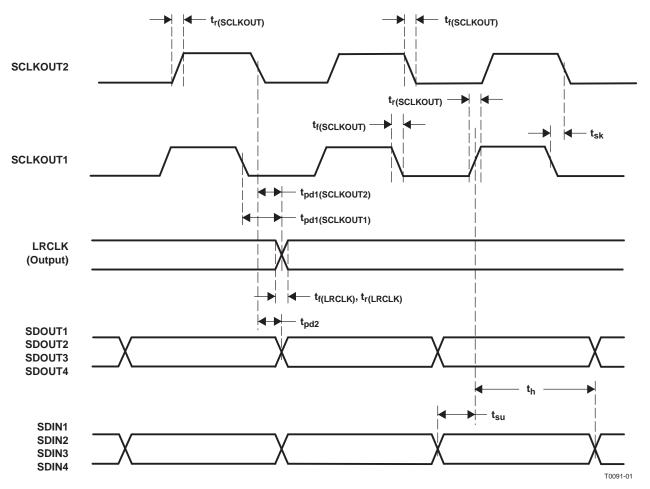


Figure 11-5. Serial Audio Port Master Mode Timing Waveforms

# 11.10 Pin-Related Characteristics of the SDA and SCL I/O Stages for F/S-Mode I<sup>2</sup>C-Bus Devices

	PARAMETER	TEST CONDITIONS	STAND/ MOD		FAST MODE		UNIT
			MIN	MAX	MIN	MAX	
VIL	LOW-level input voltage		-0.5	0.8	-0.5	0.8	V
VIH	HIGH-level input voltage		2		2		V
V <sub>hys</sub>	Hysteresis of inputs		N/A	N/A	0.05 V <sub>DD</sub>		V
V <sub>OL1</sub>	LOW-level output voltage (open drain or open collector)	3-mA sink current			0	0.4	V
t <sub>of</sub>	Output fall time from $V_{\text{IHmin}}$ to $_{\text{VILmax}}$	Bus capacitance from 10 pF to 400 pF		250	7 + 0.1 C <sub>b</sub> (1)	250	ns
I <sub>I</sub>	Input current, each I/O pin		-10	10	-10 <sup>(2)</sup>	10 <sup>(2)</sup>	μA
t <sub>SP(SCL)</sub>	SCL pulse duration of spikes that must be suppressed by the input filter		N/A	N/A	14 <sup>(3)</sup>		ns
t <sub>SP(SDA)</sub>	SDA pulse duration of spikes that must be suppressed by the input filter		N/A	N/A	22 <sup>(3)</sup>		ns
CI	Capacitance, each I/O pin			10		10	pF

(1)  $C_b$  = capacitance of one bus line in pF. The output fall time is faster than the standard I<sup>2</sup>C specification.

(2) The I/O pins of fast-mode devices must not obstruct the SDA and SDL lines if V<sub>DD</sub> is switched off.

(3) These values are valid at the 135-MHz DSP clock rate. If DSP clock is reduced by half, the t<sub>SP</sub> doubles.

# 11.11 Bus-Related Characteristics of the SDA and SCL I/O Stages for F/S-Mode I<sup>2</sup>C-Bus Devices

all values are referred to  $V_{IHmin}$  and  $V_{ILmax}$  (see Section 11.10)

		STANDARD	MODE	FAST MO	DE	
	PARAMETER	MIN	MAX	MIN	MAX	UNIT
f <sub>SCL</sub>	SCL clock frequency	0	100	0	400 <sup>(1)</sup>	kHz
t <sub>HD-STA</sub>	Hold time (repeated) START condition. After this period, the first clock pulse is generated.	4		0.6		μs
t <sub>LOW</sub>	LOW period of the SCL clock	4.7		1.3		μs
t <sub>HIGH</sub>	HIGH period of the SCL clock	4		0.6		μs
t <sub>SU-STA</sub>	Setup time for repeated START	4.7		0.6		μs
t <sub>SU-DAT</sub>	Data setup time	250		100		μs
t <sub>HD-DAT</sub>	Data hold time <sup>(2) (3)</sup>	0	3.45	0	0.9	μs
t <sub>r</sub>	Rise time of both SDA and SCL signals		1000	20 + 0.1 C <sub>b</sub> <sup>(4)</sup>	300	ns
t <sub>f</sub>	Fall time of both SDA and SCL		300	20 + 0.1 C <sub>b</sub> <sup>(4)</sup>	300	ns
t <sub>SU-STO</sub>	Setup time for STOP condition	4		0.6		μs
t <sub>BUF</sub>	Bus free time between a STOP and START condition	4.7		1.3		μs
C <sub>b</sub>	Capacitive load for each bus line		400		400	pF
V <sub>nL</sub>	Noise margin at the LOW level for each connected device (including hysteresis)	0.1V <sub>DVDD</sub>		0.1V <sub>DVDD</sub>		V
V <sub>nH</sub>	Noise margin at the HIGH level for each connected device (including hysteresis)	0.2V <sub>DVDD</sub>		0.2V <sub>DVDD</sub>		V

(1) In master mode, the maximum speed is 375 kHz.

(2) Note that SDA does not have the standard I<sup>2</sup>C specification 300-ns internal hold time. SDA must be valid by the rising and falling edges of SCL. TI recommends that a 2-k $\Omega$  pullup resistor be used to avoid potential timing issues.

(3) A fast-mode I<sup>2</sup>C-bus device can be used in a standard-mode I<sup>2</sup>C-bus system, but the requirement t<sub>SU-DAT</sub> ≥ 250 ns must then be met. This is automatically the case if the device does not stretch the LOW period of the SCL signal. If such a device does stretch the LOW period of the SCL signal, it must output the next data bit to the SDA line t<sub>r-max</sub> + t<sub>SU-DAT</sub> = 1000 + 250 = 1250 ns (according to the standard-mode I<sup>2</sup>C bus specification) before the SCL line is released.

(4)  $C_b = total capacitance of one bus line in pF$ 



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### NOTE

SDA does not have the standard  $I^2C$  specification 300-ns internal hold time. SDA must be valid by the rising and falling edges of SCL.

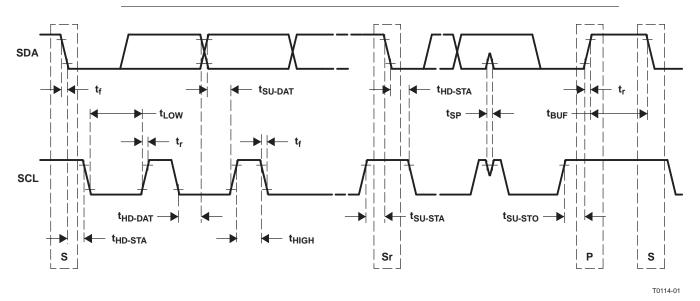


Figure 11-6. Start and Stop Conditions Timing Waveforms

# 11.11.1 Recommended <sup>*f*</sup>C Pullup Resistors

It is recommended that the I<sup>2</sup>C pullup resistors R<sub>P</sub> be 4.7 k $\Omega$  (see Figure 11-7). If a series resistor is in the circuit (see Figure 11-8), then the series resistor R<sub>S</sub> should be less than or equal to 300  $\Omega$ .

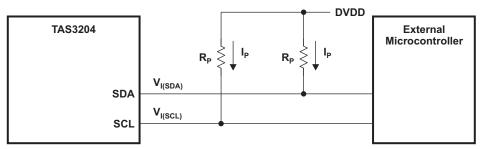
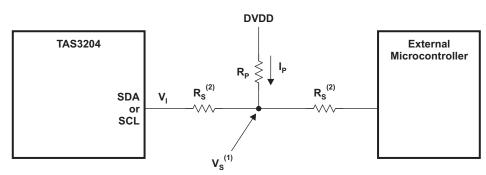


Figure 11-7. I<sup>2</sup>C Pullup Circuit (With No Series Resistor)



- (1)  $V_S = DVDD \times R_S/(R_S R_P)$ . When driven low,  $V_S \ll V_{IL}$  requirements.
- (2) R<sub>S</sub> ≤ 300 Ω

### Figure 11-8. I<sup>2</sup>C Pullup Circuit (With Series Resistor)

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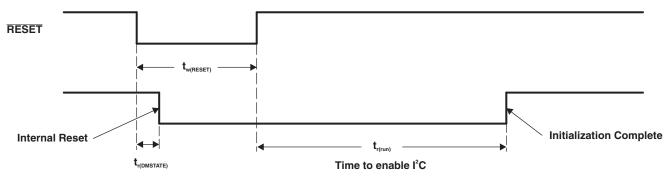
**ISTRUMENTS** 

EXAS

# 11.12 Reset Timing

control signal parameters over recommended operating conditions (unless otherwise noted)

	PARAMETER	MIN	MAX	UNIT
t <sub>w(RESET)</sub>	Pulse duration, RESET active	200		ns
t <sub>r(DMSTATE)</sub>	Time to outputs inactive		100	μs
t <sub>r(run)</sub>	Time to enable I <sup>2</sup> C	50		ms





# 12 I<sup>2</sup>C Register Map

The following  $I^2C$  registers are software mapped to some of the Extended Special Function Registers (ESFR) via the ROM code. Table 14-1 lists the  $I^2C$  sub-address that are configured for these registers if the TAS3204 MCU is executing the code stored in the ROM.

It should be noted that these I<sup>2</sup>C subaddresse are reconfigurable, thus if the TAS3204 MCU is executing custom code or code generated from the PurePath Studio<sup>™</sup> Graphical Development Environment, the I<sup>2</sup>C subaddresses listed in Table 14-1 may not be valid. Refer to the PurePath Studio<sup>™</sup> Graphical Development Environment(GDE) User's Guide for details regarding how to determine which I<sup>2</sup>C subaddress valid and how to access the registers that are remapped by the GDE.

SUBADDRESS	REGISTER NAME	NO. OF BYTES	CONTENTS	INITIALIZATION VALUE
0x00	Clock and SAP Control Register	4	Description shown in Section 12.1	0x00, 0x40, 0x1B, 0x22
0x01	Reserved	4	Reserved	0x00, 0x00, 0x00, 0x40
0x02	Status Register	4	Description shown in Section 12.3	0x00, 0x00, 0x03, 0xFF
0x03	Unused			0x00, 0x00, 0x00, 0x00
0x04	I <sup>2</sup> C Memory Load Control	8	Description shown in Section 12.4	0x00, 0x00, 0x00, 0x00 0x00, 0x00, 0x00, 0x00
0x05	I <sup>2</sup> C Memory Load Data	8	Description shown in Section 12.4	0x00, 0x00, 0x00, 0x00 0x00, 0x00, 0x00, 0x00
0x06	Memory Select and Address	4	u(31:24) <sup>(1)</sup> , MemSelect(23:16), Addr(15:8), Addr(7:0)	0x00, 0x00, 0x00, 0x00
0x07	Data Register	16	D(63:56), D(55:48), D(47:40), D(39:32), D(31:24), D(23:16), D(15:8), D(7:0)	0x00, 0x00, 0x00, 0x00 0x00, 0x00, 0x00, 0x00
0x08	Device Version	4	TAS3204 version	0x00, 0x00, 0x00, 0x01
0x09	Unused	Unused	Unused	Unused
0x10	Analog Power Down Control 1	4	Analog Power Down Control 1	0x00, 0x00, 0x00, 0x1F
0x11	Analog Power Down Control 2	4	Analog Power Down Control 2	0x00, 0x00, 0x00, 0xFF
0x12	Analog Input Control	4	Analog Input Control	0x00, 0x00, 0x00, 0x01
0x13	ADC Dynamic Element Matching	4	ADC Dynamic Element Matching	0x00, 0x00, 0x00, 0x08
0x14	ADC2 Current Control 1	4	ADC1 Current Control 1	0x00, 0x00, 0x00, 0x00
0x15	ADC2 Current Control 2	4	ADC1 Current Control 2	0x00, 0x00, 0x00, 0x00
0x16	Unused		Unused	
0x17	ADC1 Current Control 1	4	ADC2 Current Control 1	0x00, 0x00, 0x00, 0x00
0x18	ADC1 Current Control 2	4	ADC2 Current Control 2	0x00, 0x00, 0x00, 0x00
0x19	Unused	4	Unused	
0x1A	DAC Control 1	4	DAC Control 1	0x00, 0x00, 0x00, 0x00
0x1B	DAC Control 2	4	DAC Control 2	0x00, 0x00, 0x00, 0x00
0x1C	Analog Test Modes	4	Analog Test Modes	0x00, 0x00, 0x00, 0x00
0x1D	DAC Modulator Dither	4	DAC Modulator Dither	0x00, 0x00, 0x00, 0x00
0x1E	ADC/DAC Digital Reset	4	ADC/DAC Digital Reset	0x00, 0x00, 0x00, 0x00
0x1F	Analog Input Gain Select		Analog Input Gain Select	0x00, 0x00, 0x00, 0x00
0x20	Clock Delay Setting ADC	4	Clock Delay Setting ADC	0x00, 0x00, 0x00, 0x00
0x21	MCLK_OUT2 Divider	4	MCLK_OUT2 Divider	0x00, 0x00, 0x00, 0x05
0x22	MCLK_OUT3 Divider	4	MCLK_OUT3 Divider	0x00, 0x00, 0x00, 0x00
0x23	Bypass Time	4	Bypass Time	0x00, 0x00, 0x00, 0x00
0x24	Clock Delay Setting DAC	4	Clock Delay Setting DAC	0x00, 0x00, 0x00, 0x00
0x30-0x3F	Digital Cross Bar	32	Digital Cross Bar	See Section 12.15

### Table 12-1. I<sup>2</sup>C Register Map

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In the following sections, **BOLD** indicates the default state of the bit fields.

### 12.1 Clock Control Register (0x00)

Register 0x00 provides the user with control over MCLK, LRCLK, SCLKOUT1, SCLKOUT2, data-word size, and serial audio port modes. Register 0x00 default = **0x00 00 1B 22**.

Bit 31	Bit 30	Bit 29	Bit 28	Bit 27	Bit 26	Bit 25	Bit 24	DESCRIPTION
_	-	_	-	_	-	-	_	Firmware definable
Bit 23	Bit 22	Bit 21	Bit 20	Bit 19	Bit 18	Bit 17	Bit 16	DESCRIPTION
-	1	-	-	-	-	-	-	Master Mode (XTAL)
-	0	-	1	-	-	-	-	Slave mode (MCLK_IN)
Bit 15	Bit 14	Bit 13	Bit 12	Bit 11	Bit 10	Bit 9	Bit 8	DESCRIPTION
-	-	-	-	-	_	0	0	Output SAP 32 bit word
-	-	-	-	-	-	0	1	Output SAP 16 bit word
-	-	-	-	-	-	1	0	Output SAP 20 bit word
-	-	-	-	-	-	1	1	Output SAP 24 bit word
-	-	-	0	0	-	-	-	Input SAP 32 bit word
-	Ι	-	0	1	-	-	_	Input SAP 16 bit word
-	-	_	1	0	-	-	_	Input SAP 20 bit word
-	-	-	1	1	-	-	-	Input SAP 24 bit word
Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	DESCRIPTION
IM3	IM2	IM1	IM0					Input data format
				OM3	OM2	OM1	OM0	Output data format

### Table 12-2. Clock Control Register (0x00)

# 12.2 MCUcontroller Clock Control Register

This register is reserved.



### 12.3 Status Register (0x02)

The Status Register provides momory load information. When a memory load error from a particular memory occurs or immediatly after the start of a memory load, the momory load error bit for that particular memory is set to 1. When a memory load is successful for a particular memory, the error bit is cleared. The host needs to check this load status after each memory load. These bits can be cleared by firmware.

Bit 31	Bit 30	Bit 29	Bit 28	Bit 27	Bit 26	Bit 25	Bit 24	DESCRIPTION
-	_	_	_	_	_	-	_	Firmware definable
Bit 23	Bit 22	Bit 21	Bit 20	Bit 19	Bit 18	Bit 17	Bit 16	DESCRIPTION
-	-	-	-	-	-	-	-	Firmware definable
Bit 15	Bit 14	Bit 13	Bit 12	Bit 11	Bit 10	Bit 9	Bit 8	DESCRIPTION
-	-	-	-	-	-	-	-	Firmware definable
Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	DESCRIPTION
0	0	-	-	_	-	-	1	MCU program memory load error
0	0	-	-	_	-	1	_	MCU external data memory load error
0	0	-	-	_	1	-	_	Audio DSP core program memory load error
0	0	_	_	1	_	_	_	Audio DSP core upper coefficient memory load error
0	0	_	1	_	_	_	_	Audio DSP core upper data memory load error
0	0	1	_	_	_	_	_	Invalid memory select
1	1	1	1	0	0	0	0	End-of-load header error
1	1	1	1	1	1	1	1	N, IC sampling clock is 33 MHz divided by 2N
0	0	0	0	0	0	0	0	No errors

#### Table 12-3. Status Register (0x02)

NSTRUMENTS

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**EXAS** 

### 12.4 I<sup>2</sup>C Memory Load Control and Data Registers (0x04 and 0x05)

Registers 0x04 (Table 12-4) and 0x05 (Table 12-5) allow the user to download TAS3204 program code and data directly from the system  $I^2C$  controller.

The I<sup>2</sup>C slave memory load port permits the system controller to load the TAS3204 memories as an alternative to having the TAS3204 load its memory from EEPROM.

- MCU program memory
- MCU extended memory
- DAP program memory
- DAP coefficient memory
- DAP data memory

The transfer is performed by writing to two  $I^2C$  registers. The first register is a eight byte register that holds the checksum, the memory to be written, the starting address, the number of data bytes to be transferred. The second location holds 8 bytes of data. The memory load operation starts with the first register being set. Then the data is written into the second register using the format shown. After the last data byte is written into the second register, an additional two bytes are written which contain the two-byte checksum. At that point, the transfer is complete and status of the operation is reported in the status register. The end checksum is always contained in the last two bytes of the data block.

#### Table 12-4. TAS3204 Memory Load Control Register (0x04)

BYTE	DATA BLOCK FORMAT	SIZE	NOTES
1-2	Checksum code	2 bytes	Checksum of bytes 2 through N + 8. If this is a termination header, this value is 00 00.
3	Memory to be loaded	1 byte	0: MCU program memory 1: MCU external data memory 2: Audio DSP core program memory 3: Audio DSP core coefficient memory 4: Audio DSP core data memory 5: Audio DSP core upper data memory 6: Audio DSP core upper coefficient memory 7–15: Reserved for future expansion
4	Unused	1 byte	Reserved for future expansion
5–6	Starting TAS3204 memory address	2 bytes	If this is a termination header, this value is 0000.
7–8	Number of data bytes to be transferred	2 bytes	If this is a termination header, this value is 0000.

#### Table 12-5. TAS3204 Memory Load Data Register (0x05)

BYTE	8-BIT DATA	28-BIT DATA	48-BIT DATA	54-BIT DATA
1	Datum 1 Bit 7–Bit 0	0000 Bit 27-Bit 24	0000 0000	0000 0000
2	Datum 2 Bit 7–Bit 0	Bit 7–Bit 0	0000 0000	00 Bit 53–Bit 48
3	Datum 3 Bit 7–Bit 0	Bit 15–D8	Bit 47–Bit 40	Bit 47–Bit 40
4	Datum 4 Bit 7–Bit 0	Bit 7–Bit 0	Bit 39–Bit 32	Bit 39–Bit 32
5	Datum 5 Bit 7–Bit 0	0000 Bit 27-Bit 24	Bit 31–Bit 24	Bit 31–Bit 24
6	Datum 6 Bit 7–Bit 0	Bit 23–Bit 16	Bit 23–Bit 16	Bit 23–Bit 16
7	Datum 7 Bit 7–Bit 0	Bit 15–D8	Bit 15–D8	Bit 15–D8
8	Datum 8 Bit 7–Bit 0	Bit 7–Bit 0	Bit 7–Bit 0	Bit 7–Bit 0



### 12.5 Memory Access Registers (0x06 and 0x07)

Registers 0x06 (Table 12-6) and 0x07 (Table 12-7) allow the user to access the internal resources of the TAS3204. See TAS3108/TAS3108/A Firmware Programmer's Guide (SLEU067) for more details.

Bit 31	Bit 30	Bit 29	Bit 28	Bit 27	Bit 26	Bit 25	Bit 24	DESCRIPTION
-	-	-	-	-	-	_	-	Unused
Bit 23	Bit 22	Bit 21	Bit 20	Bit 19	Bit 18	Bit 17	Bit 16	DESCRIPTION
0	0	0	0	0	0	0	1	Audio DSP core coefficient memory select
0	0	0	0	0	0	1	0	Audio DSP core data memory select
0	0	0	0	0	0	1	1	Reserved
0	0	0	0	0	1	0	0	MCU internal data memory select
0	0	0	0	0	1	0	1	MCU external data memory select
0	0	0	0	0	1	1	0	SFR select
0	0	0	0	0	1	1	1	MCU program RAM select
0	0	0	0	1	0	0	0	Audio DSP core program RAM select
0	0	0	0	1	0	0	1	Audio DSP core upper memory select
0	0	0	0	1	0	1	0	Audio DSP core program RAM select
Bit 15	Bit 14	Bit 13	Bit 12	Bit 11	Bit 10	Bit 9	Bit 8	DESCRIPTION
A0	A1	A2	A3	A4	A5	A6	A7	Memory address
Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	DESCRIPTION
A8	A9	A10	A11	A12	A13	A14	A15	Memory address

#### Table 12-6. Memory Select and Address Register (0x06)

#### Table 12-7. Data Register (Peek and Poke) (0x07)

Bit 63	Bit 62	Bit 61	Bit 60	Bit 59	Bit 58	Bit 57	Bit 56	DESCRIPTION
Bit 63	Bit 62	Bit 61	Bit 60	Bit 59	Bit 58	Bit 57	Bit 56	Data to be written or read
Bit 55	Bit 54	Bit 53	Bit 52	Bit 51	Bit 50	Bit 49	Bit 48	DESCRIPTION
Bit 55	Bit 54	Bit 53	Bit 52	Bit 51	Bit 50	Bit 49	Bit 48	Data to be written or read
Bit 47	Bit 46	Bit 45	Bit 44	Bit 43	Bit 42	Bit 41	Bit 40	DESCRIPTION
Bit 47	Bit 46	Bit 45	Bit 44	Bit 43	Bit 42	Bit 41	Bit 40	Data to be written or read
Bit 39	Bit 38	Bit 37	Bit 36	Bit 35	Bit 34	Bit 33	Bit 32	DESCRIPTION
Bit 39	Bit 38	Bit 37	Bit 36	Bit 35	Bit 34	Bit 33	Bit 32	Data to be written or read
Bit 31	Bit 30	Bit 29	Bit 28	Bit 27	Bit 26	Bit 25	Bit 24	DESCRIPTION
Bit 31	Bit 30	Bit 29	Bit 28	Bit 27	Bit 25	Bit 26	Bit 25	Data to be written or read
Bit 23	Bit 22	Bit 21	Bit 20	Bit 19	Bit 18	Bit 17	Bit 16	DESCRIPTION
Bit 23	Bit 22	Bit 21	Bit 20	Bit 19	Bit 18	Bit 17	Bit 16	Data to be written or read
Bit 15	Bit 14	Bit 13	Bit 12	Bit 11	Bit 10	D9	D8	DESCRIPTION
Bit 15	Bit 14	Bit 13	Bit 12	Bit 11	Bit 10	D9	D8	Data to be written or read
Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	DESCRIPTION
Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	Data to be written or read

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# 12.6 Device Version (0x08)

Bit 31	Bit 30	Bit 29	Bit 28	Bit 27	Bit 26	Bit 25	Bit 24	DESCRIPTION	
-	-	-	Ι	-	-	I	-	Firmware definable	
Bit 23	Bit 22	Bit 21	Bit 20	Bit 19	Bit 18	Bit 17	Bit 16	DESCRIPTION	
DIT 23	DIL 22	DIT ZI	DIT 20	DIT 19	DIL IO	DIT 17	DIT 10	DESCRIPTION	
-	-	-	-	-	-	-	-	Firmware definable	
	1		1	1	1	1	1		
Bit 15	Bit 14	Bit 13	Bit 12	Bit 11	Bit 10	D9	D8	DESCRIPTION	
-	-	-	Ι	-	-	I	-	Firmware definable	
	1	1	1	1	1	1	1		
Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	DESCRIPTION	
0	0	0	0	0	0	0	1	TAS3204 device version	

### Table 12-8. Device Version

# 12.7 Analog Power Down Control (0x10 and 0x11)

### Table 12-9. Analog Power Down Control 1 (0x10)

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	DESCRIPTION
-	-	-	-	-	-	-	1	Central reference enable
-	-	-	-	_	-	-	0	Power down central reference
-	_	-	-	_	-	1	_	ADC1 enable
-	-	-	-	_	_	0	_	ADC1 power down
-	_	_	-	_	1	-	-	ADC2 enable
-	-	-	-	_	0	-	_	ADC2 power down
-	-	-	-	1	-	-	_	ADC reference enable
-	-	-	-	0	-	-	-	ADC reference power down
-	-	-	1	-	-	-	-	DAC reference enable
_	_	-	0	-	-	-	-	DAC reference power down

### Table 12-10. Analog Power Down Control 2 (0x11)

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	DESCRIPTION
-	_	-	-	_	-	-	1	DAC1 left enable
-	_	-	-	_	-	-	0	DAC1 left power down
-	_	-	-	_	-	1	_	DAC1 right enable
_	_	-	-	_	-	0	_	DAC1 right power down
-	-	-	-	-	1	-	-	DAC2 left enable
_	_	-	-	_	0	-	_	DAC2 left power down
_	_	-	-	1	-	-	_	DAC2 right enable
_	_	-	-	0	-	-	_	DAC2 right power down
_	_	-	1	_	-	-	_	Line out 1 left enable
-	-	-	0	-	-	-	-	Line out 1 left power down
-	_	1	-	_	-	-	_	Line out 1 right enable
-	_	0	-	_	-	-	_	Line out 1 right power down
-	1	-	-	_	-	-	_	Line out 2 left enable
-	0	-	_	_	-	-	-	Line out 2 left power down
1	-	-	_	-	-	_	-	Line out 2 right enable
0	-	-	-	-	-	-	-	Line out 2 right power down

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# 12.8 Analog Input Control (0x12)

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	DESCRIPTION
-	_	-	-	_	_	-	0	-
-	_	-	-	-	-	I	1	Select input 1 to ADC 1
-	-	-	-	-	-	0	-	-
-	_	-	-	-	-	1	-	Select input 1 to ADC 2
-	_	-	-	-	0	-	-	-
-	-	-	-	-	1	-	-	Select input 2 to ADC 2
-	-	-	-	0	-	-	-	-
-	_	-	-	1	-	I	-	Select input 2 to ADC 2
-	_	-	0	-	_	-	_	-
-	-	-	1	-	-	-	-	Select input 3 to ADC 2
-	-	0	-	-	-	-	-	-
-	-	1	-	-	-	-	-	Select input 3 to ADC 2
-	0	-	-	-	-	-	-	ADC 1 differential input
_	1	-	-	-	-	-	_	ADC 1 single ended input
0	_	-	-	-	_	-	-	ADC 2 differential input
1	-	-	-	-	_	_	-	ADC 2 single ended input

# Table 12-11. Analog Input Control 3 (0x12)

# 12.9 Dynamic Element Matching (0x13)

Table 12-12. D	ynamic Elemer	nt Matching (0x13)
	ynanne Liemei	it matering (0x13)

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	DESCRIPTION
-	-	-	-	-	-	-	0	ADC dynamic element matching algorithm enabled (recommended setting)
-	-	-	Ι	-	-	-	1	ADC dynamic element matching algorithm disabled
-	-	-	Ι	-	-	0	-	Dynamic weighted averaging enabled (recommended setting)
_	-	-	Ι	-	_	1	-	Dynamic weighted averaging disabled
-	-	-		-	0	_	-	Unused
_	-	-	Ι	-	1	_	-	Unused
_	_	_	-	0	_	_	_	Fast charge of cap on VREF (filtering disabled – recommended setting at startup)
_	_	-	-	1	_	_	-	Slow charge of cap on VREF (filtering enabled – recommended setting during normal operation)
-	_	-	0	-	_	_	-	Unused
-	_	-	1	-	_	-	-	Unused
-	-	0	-	-	-	_	-	Unused
_	_	1	-	-	_	_	-	Unused
-	0	-	-	-	-	-	-	Unused
-	1	-	-	-	-	-	-	Unused
0	_	-	-	-	-	_	-	Unused
1	_	-	-	-	_	_	-	Unused

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**FEXAS** 

# 12.10 Current Control Select (0x14, 0x15, 0x17, 0x18)

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	DESCRIPTION
-	-	-	_	-	-	0	0	ADC2 summer current setting (left and right) = 130% of nominal current (recommended setting)
-	-	-	-	-	-	0	1	ADC2 summer current setting (left and right) = 100% of nominal current
-	_	-	-	-	_	1	0	ADC2 summer current setting (left and right) = 100% of nominal current
-	-	-	-	-	-	1	1	ADC2 summer current setting (left and right) = 70% of nominal current
-	-	-	-	0	0	-	-	ADC2 quantizer current setting (left and right) = 137.5% of nominal current (recommended setting)
-	-	-	-	0	1	-	-	ADC2 quantizer current setting (left and right) = 100% of nominal current
-	-	-	-	1	0	-	-	ADC2 quantizer current setting (left and right) = 100% of nominal current
-	-	-	-	1	1	-	-	ADC2 quantizer current setting (left and right) = 62.5% of nominal current
-	-	0	0	Ι	-	-	-	ADC2 third integrator current setting (left and right) = 130% of nominal current (recommended setting)
-	-	0	1	-	_	-	-	ADC2 third integrator current setting (left and right) = 100% of nominal current
_	-	1	0	-	_	-	-	ADC2 third integrator current setting (left and right) = 100% of nominal current
-	-	1	1	-	-	-	-	ADC2 third integrator current setting (left and right) = 70% of nominal current
0	0	_	-	_	_	_	-	ADC2 reference buffer current setting (left and right) = 130% of nominal current (recommended setting)
0	1	-	-	Ι	-	Ι	-	ADC2 reference buffer current setting (left and right) = 100% of nominal current
1	0	-	-	-	-	-	-	ADC2 reference buffer current setting (left and right) = 100% of nominal current
1	1	-	_	_	_	_	-	ADC2 reference buffer current setting (left and right) = 70% of nominal current

# Table 12-13. Current Control Select 1(0x14)



Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	DESCRIPTION
_	-	-	-	_	-	0	0	ADC2 second integrator current setting (left and right) = 130% of nominal current (recommended setting)
-	-	Ι	-	-	-	0	1	ADC2 second integrator current setting (left and right) = 100% of nominal current
_	_	-	-	_	_	1	0	ADC2 second integrator current setting (left and right) = 100% of nominal current
-	_	-	l	-	-	1	1	ADC2 second integrator current setting (left and right) = 70% of nominal current
_	_	_	_	0	0	_	_	ADC2 second integrator current setting (left and right) = 130% of nominal current (recommended setting)
-	_	-	-	0	1	_	_	ADC2 first integrator current setting (left and right) = 100% of nominal current
-	_	-	l	1	0	_	_	ADC2 first integrator current setting (left and right) = 100% of nominal current
-	_	-	l	1	1	_	_	ADC2 first integrator current setting (left and right) = 70% of nominal current
-	_	1	0	_	-	-	-	ADC2 current for common mode buffer to integrator $1 = 3.5 \ \mu A$
_	_	-	1	_	-	-	-	ADC2 current for common mode buffer to integrator $1 = 2.0 \ \mu A$
-	-	0	-	-	-	-	-	ADC2 current for common mode buffer to integrator 2 and 3 = 3.5 $\mu$ A
-	_	1	I	_	_	-	-	ADC2 current for common mode buffer to integrator 2 and 3 = 2.0 $\mu$ A
-	0	Ι	-	-	-	-	-	ADC2 current for the buffer to the ADC sampling switches = $3.5 \ \mu A$
-	1	I	I	-	-	-	-	ADC2 current for the buffer to the ADC sampling switches = 2.0 $\mu$ A
0	-	-	-	-	-	-	-	ADC2 current for the reference buffer to the ADC DAC = 3.5 $\mu$ A
1	-	-	-	-	-	-	-	ADC2 Current for the Reference Buffer to The ADC DAC = $2.0 \ \mu A$

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Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	DESCRIPTION
-	_	-	-	_	_	0	0	ADC1 summer current setting (left and right) = 130% of nominal current (Recommended Setting)
_	-	-	-	-	-	0	1	ADC1 summer current setting (left and right) = 100% of nominal current
_	-	-	-	-	_	1	0	ADC1 summer current setting (left and right) = 100% of nominal current
-	-	Ι	Ι	-	Ι	1	1	ADC1 summer current setting (left and right) = 70% of nominal current
-	-	-	-	0	0	-	-	ADC1 quantizer current setting (left and right) = 137.5% of nominal current (recommended setting)
-	_	Ι	Ι	0	1	-	-	ADC1 quantizer current setting (left and right) = 100% of nominal current
-	_	-	l	1	0	_	-	ADC1 quantizer current setting (left and right) = 100% of nominal current
-	_	-	-	1	1	_	_	ADC1 quantizer current setting (left and right) = 62.5% of nominal current
-	_	0	0	-	-	-	_	ADC1 third integrator current setting (left and right) = 130% of nominal current (Recommended Setting)
-	_	0	1	_	_	_	-	ADC1 third integrator current setting (left and right) = 100% of nominal current
-	_	1	0	_	_	_	-	ADC1 third integrator current setting (left and right) = 100% of nominal current
_	_	1	1	_	_	_	-	ADC1 third integrator current setting (left and right) = 70% of nominal current
0	0	-	-	-	-	_	_	ADC1 reference buffer current setting (left and right) = 130% of nominal current (Recommended Setting)
0	1	_	_	_	_	_	-	ADC1 reference buffer current setting (left and right) = 100% of nominal current
1	0	_	_	_	-	_	-	ADC1 reference buffer current setting (left and right) = 100% of nominal current
1	1	_	_	_	-	-	-	ADC1 reference buffer current setting (left and right) = 70% of nominal current

# Table 12-15. Current Control Select 3 (0x17)

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Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	DESCRIPTION
_	-	-	-	_	-	0	0	ADC1 second integrator current setting (left and right) = 130% of nominal current (recommended setting)
-	-	-	-	-	-	0	1	ADC1 second integrator current setting (left and right) = 100% of nominal current
-	Ι	Ι	Ι	-	Ι	1	0	ADC1 second integrator current setting (left and right) = 100% of nominal current
-	Ι	Ι	-	-	-	1	1	ADC1 second integrator current setting (left and right) = 70% of nominal current
_	-	-	-	0	0	_	-	ADC1 second integrator current setting (left and right) = 130% of nominal current (recommended setting)
-	Ι	Ι	Ι	0	1	-	-	ADC1 first integrator current setting (left and right) = 100% of nominal current
-	-	Ι	-	1	0	-	-	ADC1 first integrator current setting (left and right) = 100% of nominal current
-	-	Ι	-	1	1	-	-	ADC1 first integrator current setting (left and right) = 70% of nominal current
-	-	0	0	_	-	-	-	ADC1 current for common mode buffer to integrator $1 = 3.5 \ \mu A$
-	-	0	1	_	-	-	-	ADC1 current for common mode buffer to integrator $1 = 2.0 \ \mu A$
-	-	1	0	-	-	-	-	ADC1 current for common mode buffer to integrator 2 and 3 = 3.5 $\mu$ A
-	-	1	1	-	-	-	-	ADC1 current for common mode buffer to integrator 2 and 3 = 2.0 $\mu A$
0	0	-	-	_	-	_	-	ADC1 current for the buffer to the ADC sampling switches = $3.5 \ \mu A$
0	1	-	I	-	-	-	-	ADC1 current for the buffer to the ADC sampling switches = $2.0 \ \mu A$
1	0	-	-	-	-	-	-	ADC1 current for the reference buffer to the ADC DAC = 3.5 $\mu$ A
1	1	-	-	_	-	-	-	ADC1 current for the reference buffer to the ADC DAC = 2.0 $\mu$ A

# Table 12-16. Current Control Select 4 (0x18)

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# 12.11 DAC Control (0x1A, 0x1B, 0x1D)

# Table 12-17. DAC Control 1 (0x1A)

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	DESCRIPTION
-	-	-	-	-	-	0	0	DAC1 current control for DAC local reference block and lineout amps = default (recommended setting)
-	-	-	-	-	-	0	1	DAC1 current control for DAC local reference block and lineout amps = 125% bias current
-	-	-	-	_	-	1	0	DAC1 current control for DAC local reference block and lineout amps = 75% bias current
Ι	_	Ι	_	_	_	1	1	DAC1 current control for DAC local reference block and lineout amps = 75% bias current
-	_	-	-	0	0	_	-	DAC2 current control for DAC local reference block and lineout amps = default (recommended setting)
-	_	Ι	_	0	1	-	_	DAC2 current control for DAC local reference block and lineout amps = 125% bias current
-	-	-	-	1	0	_	-	DAC2 current control for DAC local reference block and lineout amps = 75% bias current
-	_	-	_	1	1	_	-	DAC2 current control for DAC local reference block and lineout amps = 75% bias current
-	_	-	_	_	-	-	-	-
-	_	-	-	_	-	_	-	-
_	_	-	-	_	-	_	_	-
-	-	-	-	-	-	-	-	-
-	-	-	-	-	-	-	-	-
-	_	-	-	_	_	_	-	-
-	-	-	-	-	-	_	-	-
-	_	-	-	_	-	_	-	-

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Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	DESCRIPTION
-	-	I	I	-	-	-	0	DAC1 chopper stabilization disable
-	_	-	-	_	_	_	1	DAC1 chopper stabilization enable
-	_	-	-	_	-	0	-	DAC2 chopper stabilization disable
-	_	-	-	_	-	1	-	DAC2 chopper stabilization enable
-	_	-	-	_	0	_	-	DC offset subtraction in DACs 1 and 2 disable
-	_	1	-	-	1	-	-	DC offset subtraction in DACs 1 and 2 enable
-	_	-	-	0	-	_	-	Connected to MCU SDA2
-	_	-	-	1	-	_	-	
-	_	-	-	_	-	_	-	-
-	-	-	-	-	-	-	-	-
-	-	-	-	-	-	-	-	-
-	_	-	-	_	-	-	-	-
-	_	-	-	_	-	-	-	-
-	-	-	-	-	-	-	-	-
-	_	-	-	-	-	-	-	-
-	_	-	-	_	-	_	-	-

# Table 12-18. DAC Control 2 (0x1B)

# Table 12-19. DAC Control 3 (0x1D)

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	DESCRIPTION
-	-	-	-	-	-	0	0	DAC1 current control for DAC local reference block and lineout amps = default (recommended setting)
-	-	-	-	-	-	0	1	DAC1 current control for DAC local reference block and lineout amps = 125% bias current
-	-	-	-	-	-	1	0	DAC1 current control for DAC local reference block and lineout amps = 75% bias current
_	_	_	-	_	-	1	1	DAC1 current control for DAC local reference block and lineout amps = 75% bias current
-	_	-	-	0	0	_	-	DAC2 current control for DAC local reference block and lineout amps = default (recommended setting)
_	_	_	-	0	1	-	_	DAC2 current control for DAC local reference block and lineout amps = 125% bias current
_	_	_	-	1	0	_	_	DAC2 current control for DAC local reference block and lineout amps = 75% bias current
_	_	_	-	1	1	_	_	DAC2 current control for DAC local reference block and lineout amps = 75% bias current
-	-	-	-	_	-	-	-	-
-	_	-	-	_	-	-	_	-
-	_	-	-	_	-	-	-	-
-	-	-	-	-	-	-	-	-
-	-	-	-	-	-	-	-	-
-	_	-	-	-	-	_	-	-
-	_	-	-	-	-	_	-	-
-	-	-	-	-	-	-	-	-

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# 12.12 ADC and DAC Reset (0x1E)

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	DESCRIPTION
-	_	-	-	_	-	-	0	-
-	_	-	-	_	-	-	1	ADC reset channel 1
_	_	-	-	_	-	0	-	-
-	_	1	-	_	1	1	-	ADC reset channel 2
-	_	-	-	_	0	-	_	-
-	-	-	-	-	1	-	-	ADC reset channel 3
-	_	-	-	0	-	-	_	-
_	_	-	-	1	-	-	-	ADC reset channel 4
-	_	-	0	_	1	1	_	-
-	-	-	1	-	-	-	-	DAC reset channel 1
-	-	0	-	-	-	-	-	-
-	-	1	-	-	-	-	-	DAC reset channel 2
_	0	-	-	_	-	-	-	-
_	1	-	-	_	-	-	-	DAC reset channel 3
0	-	-	-	-	-	-	-	-
1	-	_	_	-	-	_	-	DAc reset channel 4

### Table 12-20. ADC and DAC Reset (0x1E)

# 12.13 ADC Input Gain Control (0x1F)

### Table 12-21. ADC Input Gain Control (0x1F)

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	DESCRIPTION
-	-	-	-	-	-	0	0	Channel 1Sinc input gain control = 0 dB
_	_	-	-	_	-	0	1	Channel 1Sinc input gain control = +30 dB
_	_	-	-	_	-	1	0	Channel 1Sinc input gain control = +600 dB
_	_	-	-	_	-	1	1 Channel 1Sinc input gain control = 0 dB	
_	_	-	-	0	0	-	-	Channel 2Sinc input gain control = 0 dB
_	_	_	-	0	1	-	-	Channel 2Sinc input gain control = +30 dB
_	_	_	1	1	0	I	-	Channel 2Sinc input gain control = +60 dB
_	_	-	-	1	1	-	-	Channel 2Sinc input gain control = 0 dB
_	_	0	0	_	-	-	-	Channel 3Sinc input gain control = 0 dB
-	-	0	1	-	-	-	-	Channel 3Sinc input gain control = +30 dB
-	-	1	0	-	-	-	-	Channel 3Sinc input gain control =+60 dB
_	_	1	1	_	-	-	-	Channel 3Sinc input gain control = 0 dB
0	0	-	-	_	-	-	-	Channel 4Sinc input gain control = 0 dB
0	1	-	_	_	_	_	-	Channel 4Sinc input gain control = +30 dB
1	0	-	-	-	-	-	-	Channel 4Sinc input gain control = +60 dB
1	1	-	-	-	-	_	-	Channel 4Sinc input gain control = 0 dB



# 12.14 MCLK\_OUT Divider (0x21 and 0x22)

### Table 12-22. MCLK\_OUT 2 (0x21)

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	DESCRIPTION
0	0	0	0	0	1	0	1	MCLK_OUT2 frequency is 6.144 MHz/(divider+1)

### Table 12-23. MCLK\_OUT 3 (0x22)

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	DESCRIPTION
0	0	0	0	0	0	0	0 MCLK_OUT3 frequency is 512 kHz/(divider+1)	

# 12.15 Digital Cross Bar (0x30 to 0x3F)

#### Table 12-24. Digital Cross Bar (0x30 to 0x3F)

SUBADDRESS	REGISTER NAME	NO. OF BYTES	CONTENTS	INITIALIZATION VALUE
0x30	CH1 Input Mixer	32	Input cross bar mux	0x08 00 00 00           0x00 00 00 00
0x31	CH2 Input Mixer	32	Input cross bar mux	0x00 00 00 00 0x08 00 00 00 0x00 00 00
0x32	CH3 Input Mixer	32	Input cross bar mux	0x00 00 00 00 0x00 00 00 0x08 00 00 0x00 00 00
0x33	CH4 Input Mixer	32	Input cross bar mux	0x00 00 00 00 0x00 00 00 0x00 00 00 0x08 00 00 0x00 00 00 0x00 00 00 0x00 00 00 0x00 00 00 0x00 00 00 0x00 00 00
0x34	CH5 Input Mixer	32	Input cross bar mux	0x00 00 00 00 0x00 00 00 0x00 00 00 0x00 00 00 0x00 00 00 0x08 00 00 0x00 00 00 0x00 00 00 0x00 00 00 0x00 00 00

SUBADDRESS	REGISTER NAME	NO. OF BYTES	CONTENTS	INITIALIZATION VALUE
0x35	CH6 Input Mixer	32	Input cross bar mux	0x00 00 00 00 0x00 00 00 0x00 00 00 0x00 00 00 0x00 00 00 0x00 00 00 0x08 00 00 0x00 00 00 0x00 00 00 0x00 00 00 0x00 00 00
0x36	CH7 Input Mixer	32	Input cross bar mux	0x00       00       00
0x37	CH8 Input Mixer	32	Input cross bar mux	0x00 00 00 00 0x00 00 00 00
0x38	CH1 Output Mixer	32	Input cross bar mux	0x08 00 00 00           0x00 00 00 00
0x39	CH2 Output Mixer	32	Input cross bar mux	0x00       00       00         0x08       00       00         0x00       00       00
0x3A	CH3 Output Mixer	32	Input cross bar mux	0x00       00       00         0x00       00       00         0x08       00       00         0x00       00       00
0x3B	CH4 Output Mixer	32	Input cross bar mux	0x00 00 00 00 0x00 00 00 00 0x00 00 00 00 0x08 00 00 00 0x00 00 00 00
0x3C	CH5 Output Mixer	32	Input cross bar mux	0x00       00       00         0x00       00       00

# Table 12-24. Digital Cross Bar (0x30 to 0x3F) (continued)

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SUBADDRESS	REGISTER NAME	NO. OF BYTES	CONTENTS	INITIALIZATION VALUE
0x3D	CH6 Output Mixer	32	Input cross bar mux	0x00         00         00           0x00         00         00
0x3E	CH7 Output Mixer	32	Input cross bar mux	0x00         00         00
0x3F	CH8 Output Mixer	32	Input cross bar mux	0x00       00       00

### Table 12-24. Digital Cross Bar (0x30 to 0x3F) (continued)

### 12.16 Extended Special Function Registers (ESFR) Map

ESFR provide communication between the embedded MCU and the DSP core. The following table outlines the functionality of the ESFRs. These registers should only be accessed if the user intend to write custom TAS3204 MCU Program Code as changing some of these registers may result in undesired or unspecified operation of the TAS3204 DAP.

ESFR	MAPPED_TO	NO. OF BITS	DIRECTION	CONNECTING BLOCK	REGISTER TYPE	DESCRIPTION
	di_o	8	OUT	l <sup>2</sup> C	8-bit asynchronous rstz positive edge triggered Reset low	Data to be transferred from MCU to I <sup>2</sup> C
85	da_i	8	IN	l <sup>2</sup> C	NO REG - direct input	Data to be transferred from $I^2C$ to MCU during slave write in $I^2C$ slave-write mode if the MCU controls $I^2C$ interface
86	sub_addr_i	8	IN	l <sup>2</sup> C	NO REG – direct input	Indicates the type of information being relayed to the MCU. This affects how the MCU changes the data that follows the subaddress.
91	data_out1_i	8	IN	I <sup>2</sup> C	NO REG – direct input	
92	data_out2_i	data_out2_i 8 IN		l <sup>2</sup> C	NO REG – direct input	These registers are used to deliver data
93	data_out3_i	8	IN	l <sup>2</sup> C	NO REG – direct input	from the I <sup>2</sup> C block to the MCU.
94	data_out4_i	8	IN	l <sup>2</sup> C	NO REG – direct input	_
95	A_o	3	OUT	l <sup>2</sup> C	8-bit asynchronous rstz positive edge triggered Reset Low	Address of I <sup>2</sup> C internal registers. See Mentor I <sup>2</sup> C product specification.
96	i2s_word_byte_t	8	OUT	SAP	8-bit asynchronous rstz positive edge triggered Reset Low	Bit definition follows functional spec definition for specification SAP WORD byte
97	i2s_mode_byte_t	8	OUT	SAP	8-bit asynchronous rstz positive edge triggered Reset Low	Bit definition follows functional spec definition for specification SAP mode byte
A1	MLRCLK_t	5	OUT	CLOCK	5-bit asynchronous rstz positive edge triggered Reset Low	Bit definition follows functional spec definition for specification MLRCLK field

### Table 12-25. Extended Special Fucntion Registers (ESFR)

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## Table 12-25. Extended Special Fucntion Registers (ESFR) (continued)

	Table 12-25. Extended Special Fucntion Registers (ESFR) (continued)         ESFR       MAPPED TO       NO. OF       DIRECTION       CONNECTING       REGISTER TYPE       DESCRIPTION													
ESFR	MAPPED_TO	NO. OF BITS	DIRECTION	CONNECTING BLOCK	REGISTER TYPE	DESCRIPTION								
A2	SCLK_t	8	OUT	CLOCK	8-bit asynchronous rstz positive edge triggered Reset Low	Bit definition follows functional spec definition for specification SCLK field								
A3	addr_sel_t	4	OUT	DELAY_MEM	4-bit asynchronous rstz positive edge triggered Reset Low	Delay memory select lines								
A4	addr_t	8	OUT	DELAY_MEM	8-bit asynchronous rstz positive edge triggered Reset Low	Delay memory address bus								
A5	addr_t	5	OUT	DELAY_MEM	5-bit asynchronous rstz positive edge triggered Reset Low	Delay memory address bus high bits								
A6	vol_mode_i_t	2	OUT	VOLUME	2-bit asynchronous rstz positive edge triggered Reset Low	Specify slew rate 0, 1, 2 (2048, 4096, 8192)								
A7	volume_index_i_t	3	OUT	VOLUME	3-bit asynchronous rstz positive edge triggered Reset Low	Host control channel specification								
A9		8	OUT	VOLUME	8-bit asynchronous rstz positive edge triggered Reset Low									
AA	vol_data_i_t	8	OUT	VOLUME	8-bit asynchronous rstz positive edge triggered Reset Low	Volume coefficient								
AB	vol_data_i_t 8		OUT	VOLUME	8-bit asynchronous rstz positive edge triggered Reset Low									
AC	vol_data_i_t	4	OUT	VOLUME	4-bit asynchronous rstz positive edge triggered Reset Low									
AD	To_MCU_i[7:0]	8	IN	DSP	NO REG – direct input									
AE	To_MCU_i[15:8]	8	IN	DSP	NO REG – direct input									
AF	To_MCU_i[23:16]	8	IN	DSP	NO REG – direct input									
B1	To_MCU_i[31:24]	8	IN	DSP	NO REG – direct input	Data bus from DSP to the MCU								
B2	To_MCU_i[39:32]	8	IN	DSP	NO REG – direct input	_								
Bit 6	To_MCU_i[47:40]	8	IN	DSP	NO REG – direct input	_								
Bit 7	To_MCU_i[53:48]	8	IN	DSP	NO REG – direct input									
B3	Data_to_DSP_o[7:0]	8	OUT	DSP	8-bit asynchronous rstz positive edge triggered Reset Low									
B4	Data_to_DSP_o[15:0]	8	OUT	DSP	8-bit asynchronous rstz positive edge triggered									
B5	Data_to_DSP_o[23:16]	8	OUT	DSP	8-bit asynchronous rstz positive edge triggered	_								
B6	Data_to_DSP_o[31:24]	8	OUT	DSP	8-bit asynchronous rstz positive edge triggered Reset Low	Data bus from MCU to the DSP								
B7	Data_to_DSP_o[39:32	8	OUT	DSP	8-bit asynchronous rstz positive edge triggered Reset Low									
B9	Data_to_DSP_o[47:40]	8	OUT	DSP	8-bit asynchronous rstz positive edge triggered Reset Low									
BA	Data_to_DSP_o[53:48]	8	OUT	DSP	8-bit asynchronous rstz positive edge triggered Reset Low									
BB	MCU_addr_o[7:0]	8	OUT	DSP	8-bit asynchronous rstz positive edge triggered Reset Low	MCU uses these 16 bits to set DSP RAM and MCU I addresses								
BC	MCU_addr_o[13:8]	8	OUT	DSP	8-bit asynchronous rstz positive edge triggered Reset Low	MCU uses these 16 bits to set DSP RAM and MCU I addresses Bit 10 of the address selects between audio DSP coefficient and audio DSP data memory								

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# Table 12-25. Extended Special Fucntion Registers (ESFR) (continued)

ESFR	MAPPED_TO	NO. OF	DIRECTION	CONNECTING	on Registers (ESFR REGISTER TYPE	DESCRIPTION		
ESFR	MAPPED_TO	BITS	DIRECTION	BLOCK	REGISTER TTPE	DESCRIPTION		
BD	Mode0_o	1	OUT	DSP	1-bit asynchronous rstz positive edge triggered Reset low	Miscellaneous signal for MCU-DSP		
BE	Mode3_o	1	OUT	DSP	1-bit asynchronous rstz positive edge triggered, Reset low	Communication. This is not a bit-addressable register, but contains bit data. The firmware must read ir the data, mask the change, and write it bac		
BF	Mode4_o	1	OUT	DSP	1-bit asynchronous rstz positive edge triggered Reset low	out.		
C1	C1 Mode5_o	1	OUT	DSP	1-bit asynchronous rstz positive edge triggered Reset low	_		
C2	Mode6_o	1	OUT	DSP	1-bit asynchronous rstz positive edge triggered Reset low	Miscellaneous signal for MCU-DSP communication. This is not a bit-addressable register, but		
C3	Mode7_o	1	OUT	DSP	1-bit asynchronous rstz positive edge triggered Reset low	contains bit data. The firmware must read in the data, mask the change, and write it back out.		
C4	Mode8_o	1	OUT	DSP	1-bit asynchronous rstz positive edge triggered Reset low			
C5	GPIO_IN_t	1	IN	DSP	1-bit asynchronous rstz positive edge triggered Reset Low	Registered input GPIO sense line		
C6	gpio_enz_t	1	OUT	GPIO	4-bit asynchronous rstz positive edge triggered Reset Low	GPIO bidirect configuration—low $\rightarrow$ output, high $\rightarrow$ input		
C7	gpio_out_t	1	OUT	GPIO	1-bit asynchronous rstz positive edge triggered Reset Low	Drive value on GPIO line when configured as output		
C9	cs1	1	IN	CHIP_SEL	1-bit asynchronous rstz positive edge triggered Reset Low	Reset-low sense lines for chip-select input/output		
CA	tb_loop_count_t	8	OUT	TONE	8-bit asynchronous rstz positive edge triggered Reset Low	Tone slew rate counter configuration		
СВ	dlymemif_out	8	IN	DLY_MEM	NO REG – direct input	Low-byte delay interface date port		
CC	dlymemif_out	8	IN	DLY_MEM	NO REG – direct input	High-byte delay interface date port		
CD	dlymemif_out	8	IN	DLY_MEM	NO REG – direct input	High-byte delay interface date port		
CE	cntrl1_treb_active_t	1	OUT	TONE	1-bit asynchronous rstz positive edge triggered Reset low			
CF	cntrl2_treb_active_t	1	OUT	TONE	1-bit asynchronous rstz positive edge triggered Reset low			
Bit 0	cntrl3_treb_active_t	1	OUT	TONE	1-bit asynchronous rstz positive edge triggered Reset low	Schedule tone coefficient calculations in the		
Bit 1	cntrl4_treb_active_t	1	OUT	TONE	1-bit asynchronous rstz positive edge triggered Reset low	audio DSP		
Bit 2	cntrl1_bass_active_t	1	OUT	TONE	1-bit asynchronous rstz positive edge triggered Reset low			
Bit 3	Bit 3 cntrl2_bass_active_t		OUT	TONE	1-bit asynchronous rstz positive edge triggered Reset low	1		
Bit 4	cntrl3_bass_active_t	1	OUT	TONE	1-bit asynchronous rstz positive edge triggered Reset low	Schedule tone coefficient calculations in the audio DSP		
Bit 5	cnrtrl4_bass_active_t	1	OUT	TONE	1-bit asynchronous rstz positive edge triggered Reset low	Schedule tone coefficient calculations in the audio DSP		

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# Table 12-25. Extended Special Fucntion Registers (ESFR) (continued)

ESFR	MAPPED_TO	NO. OF		CONNECTING		DESCRIPTION
LOIN		BITS	DIRECTION	BLOCK	REGIOTER TITE	
C0(0)	I2c_irg_o	1	OUT	l²C	1-bit asynchronous rstz positive edge triggered ONE SHOT (PULSE) Reset low	PULSE REGISTER Slave read: set high when MCU recognizes that the SLAVE_READ bit on the I <sup>2</sup> C has been set high. Slave write: if the RCVD_DATA_STAT bit is set high by the I <sup>2</sup> C, MCU sets IRG high in response.
C0(1)	l2c_mcu_o	1	OUT	l <sup>2</sup> C	1-bit asynchronous rstz positive edge triggered RESET HI	PULSE REGISTER I2C_MCU is set to 1 MCU assumes control over the I <sup>2</sup> C interface. If it is set to 0, the I <sup>2</sup> C block has control. If the MCU reads a 1 on slave_read, it sends an ACK to the I <sup>2</sup> C and sets I2C_MCU high.
C0(2)	update_volume_t	1	OUT	VOLUME	1-bit asynchronous rstz positive edge triggered Reset low	Signoff assertion that volume coefficients to volume block are updated and execution is commanded
C0(3)	clr_dly_RAM_t	1	OUT	DLY_MEM	1-bit asynchronous rstz positive edge triggered Reset low	Used during initialization to inspire self-clearing logic activation to the delay RAM
C0(4)	wr_t	1	OUT	I <sup>2</sup> C	1-bit asynchronous rstz positive edge triggered ONE SHOT (PULSE)	PULSE REGISTER I <sup>2</sup> C write pulse for slave transmit and master transmit
C0(5)	l2c_sel_o	1	OUT	l <sup>2</sup> C	1-bit asynchronous rstz positive edge triggered	The I <sup>2</sup> C has two registers to which the MCU can write. This signal selects one of them.
C0(6)	MCU_RAM_we_req_o	1	OUT	DSP	1-bit asynchronous rstz positive edge triggered ONE SHOT (PULSE)	PULSE REGISTER When DSP_HOST = 1, the MCU has direct control of the RAMs and pulses this signal to write to them.
C0(7)	MCU_rd_req_o	1	OUT	DSP	1-bit asynchronous rstz positive edge triggered ONE SHOT (PULSE)	When DSP_HOST is high and the MCU has complete control of the DSP RAMS, this bit is N/A. When DSP_HOST is low, the MCU uses this bit to submit a read request to the DSP.
C8(0)	power_down_in	1	IN	CNTL	NO REG – direct input	Power-down pin sense
C8(2)	vol_busy_o	1	IN	VOL	1-bit asynchronous rstz positive edge triggered Reset High	Volume busy flag
C8(3)	mem_bist_i	1	IN	membist	Direct input	Indicates chip is in firmware BIST mode
C8(4)	intr	1	IN	CNTL	Direct input	Indicates status warp IFLAG
C8(5)	MCU_ack_I	1	IN	DSP	1-bit asynchronous rstz positive edge triggered Reset low	DSP sets this bit to notify MCU it has captured data
C8(6)	clearing_dly_RAM_t	1	IN	DSP	1-bit asynchronous rstz positive edge triggered Reset low	Busy flag from Delay RAM Init clear process
C8(7)	dsp_rom_bist_I	1	IN	DSP	NO REG – direct input	Set HIGH to signal that DSP ROM BIST completed successfully
D8(0)	power_down_o	1	OUT	Multiple blks	1-bit asynchronous rstz positive edge triggered Reset low	Set HIGH by the MCU. (Need more info)
D8(1)	watchdog_clr_t	1	OUT	CNTL	1-bit asynchronous rstz positive edge triggered Reset low	Strobe to the watchdog timer logic
D8(2)	slave_mode_t	1	OUT	DLY_MEM	1-bit asynchronous rstz positive edge triggered Reset low	Asserted to provide direct delay memory access to the host (MCU)
D8(3)	addr_wr_t	1	OUT	DLY_MEM	1-bit asynchronous rstz positive edge triggered Reset low	Write assertion to delay memory during host control configuration
D8(4)	MCU_wr_en_i_t	1	OUT	DSP	1-bit asynchronous rstz positive edge triggered Reset low	Write enable signal to the audio DSP coefficients and DATA RAMs
D8(5)	host_DSP_o	1	OUT	DSP	1-bit asynchronous rstz positive edge triggered Reset high	Sets the DSP in host mode. MCU is in control

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**EXAS** 

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ESFR	MAPPED_TO	NO. OF BITS	DIRECTION	CONNECTING BLOCK	REGISTER TYPE	DESCRIPTION		
D8(6)	bass_data_ready_o	1	OUT	T/B	1-bit asynchronous rstz positive edge triggered Reset low	MCU notifies T/B block that bass data has been processed and is ready.		
D8(7)	treble_data_ready_o	1	OUT	T/B	1-bit asynchronous rstz positive edge triggered Reset low	MCU notifies T/B block that treble data has been processed and is ready.		
						00 Audio DSP coefficient/data (Depending on address bit 10)		
D9	MEM_SEL	2	OUT	MCU DAP	2-bit asynchronous rstz positive edge triggered	01 Audio DSP instruction		
					Reset low	10 MCU instruction		
						11 Reserved		
FC	i2c_ms_ctl	1	OUT	l <sup>2</sup> C	1-bit asynchronous rstz positive edge triggered Reset low	Select Master or Slave mode by switching mux		
FD	pc_source	1	OUT		1-bit asynchronous rstz positive edge triggered Reset low	Changes source from MCU program ROM to MCU program RAM		
FE	sap_en_t	1	OUT	SAP	1-bit asynchronous rstz positive edge triggered Reset Low	Expected to toggle high, then low, to inspire a recent SAP change to activate.		

TEXAS INSTRUMENTS

# **13** Application Information

### 13.1 Schematics

Figure 13-1 shows a typical TAS3204 application. In this application the following conditions apply:

- TAS3204 is in clock-master mode. The TAS3204 generates MCLK\_OUT1, SCLK\_OUT, and LRCLOK\_OUT.
- XTAL\_IN = 24.576 MHz
- I<sup>2</sup>C register 0x00 contains the default settings, which means:
  - Audio data word size is 24-bit input and 24-bit output.
  - Serial data format is 2-channel, I<sup>2</sup>S for input and output.
  - $I^2C$  data transfer is approximately 400 kbps for both master and slave  $I^2C$  interfaces.
  - Sample frequency ( $f_S$ ) is 48 kHz, which means that  $f_{LRCLK}$  = 48 kHz and  $f_{SCLKIN}$  = 3.072 MHz.
- Application code and data are loaded from an external EEPROM using the master I<sup>2</sup>C interface.
- Application commands come from the system MCU to the TAS3204 using the slave I<sup>2</sup>C interface.

Good design practice requires isolation between the digital and analog power as shown. Power supply capacitors of 10  $\mu$ F and 0.1  $\mu$ F should be placed near the power supply pins AVDD (AVSS) and DVDD (DVSS).

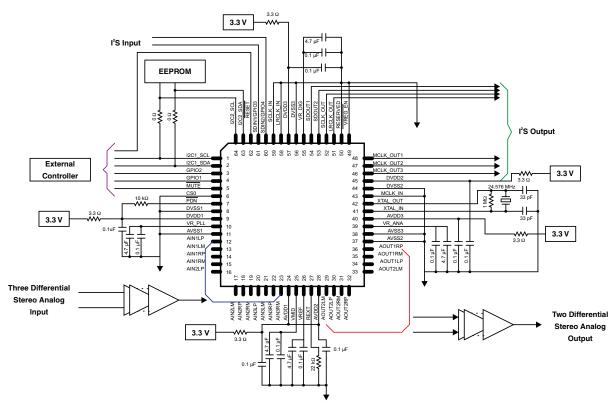
The TAS3204 reset needs external glitch protection. Also, reset going HIGH should be delayed until TAS3204 internal power is good (~200  $\mu$ s after power up). This is provided by the 1-k $\Omega$  resistor, 1- $\mu$ F capacitor, and diode placed near the RESET pin.

It is recommended that a 4.7-µF capacitor (fast ceramic type) be placed near pin 28 (VR\_DIG). This pin must not be used to source external components.



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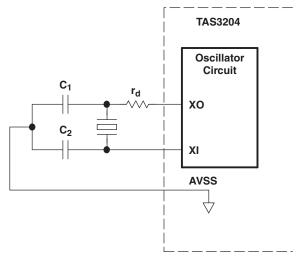




A. Capacitors should be placed as close as possible to the power supply pins.

Figure 13-1. Typical Application Diagram

### 13.2 Recommended Oscillator Circuit



- Crystal type = parallel-mode, fundamental-mode crystal
- r<sub>d</sub> = drive-level control resistor vendor specified
- C<sub>L</sub> = Crystal load capacitance (capacitance of circuitry between the two terminals of the crystal)
- $C_L = (C_1 \times C_2)/(C_1 + C_2) + C_S$  (where  $C_S$  = board stray capacitance, ~2 pF)



10-Dec-2020

# PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
TAS3204PAG	ACTIVE	TQFP	PAG	64	160	RoHS & Green	NIPDAU	Level-4-260C-72 HR	0 to 70	TAS3204PAG	Samples
TAS3204PAGR	ACTIVE	TQFP	PAG	64	1500	RoHS & Green	NIPDAU	Level-4-260C-72 HR	0 to 70	TAS3204PAG	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <= 1000ppm threshold. Antimony trioxide based flame retardants must also meet the <= 1000ppm threshold requirement.

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

<sup>(5)</sup> Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

<sup>(6)</sup> Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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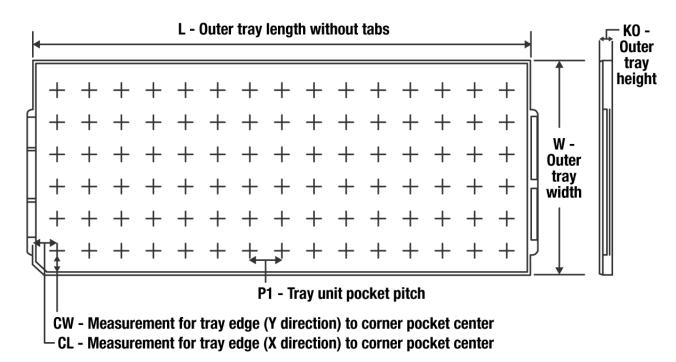
10-Dec-2020

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### TRAY

5-Jan-2022



Chamfer on Tray corner indicates Pin 1 orientation of packed units.

\*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	Unit array matrix	Max temperature (°C)	L (mm)	W (mm)	K0 (µm)	P1 (mm)	CL (mm)	CW (mm)
TAS3204PAG	PAG	TQFP	64	160	8 x 20	150	315	135.9	7620	15.2	13.1	13

# **MECHANICAL DATA**

MTQF006A - JANUARY 1995 - REVISED DECEMBER 1996

### PAG (S-PQFP-G64)

PLASTIC QUAD FLATPACK



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Falls within JEDEC MS-026



# LAND PATTERN DATA



A. All linear dimensions are in millimeters.B. This drawing is subject to change without notice.

- C. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.
- D. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



# LAND PATTERN DATA



A. All linear dimensions are in millimeters.B. This drawing is subject to change without notice.

- C. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.
- D. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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